

ICL5101

Resonant controller IC with PFC for LED driver

Datasheet

Rev. 1.3, 2016-01-15



Resonant controller IC with PFC for LED driver

Product highlights

- Resonant Controller and PFC within one IC
- Supports universal input and wide output range
- Low count of external components supporting small form factors and improved reliability
- All parameters set by simple resistors only
- Supports outdoor use by extended junction temperature range from -40 °C to +125 °C
- Stable low load operation mode down to 0.1 % of nominal power rating
- Comprehensive set of protection to increase system safety
- Ultra-fast time to light < 200 ms
- Power Factor Correction > 99 %, THD < 5 %
- High efficiency up to 94 %

PFC feature set

- PFC in CrCM mode during nominal load and DCM mode in low load condition down to 0.1 % for operation without audible noise
- Adjustable THD compensation of AC input current even in DCM operation for lowest THD
- Adjustable PFC current limitation

Resonant half bridge feature set

- · Fully integrated 650 V high-side driver
- Self-adaptive dead time control of the integrated half bridge driver 500 ns – 1.0 μs
- Detection of capacitive operation, overload, short circuitry, output overvoltage and external over temperature protection to detecting hot spots in system
- Improved operation control in magnetic saturation during start-up
- Advanced error detection control



Applications

- LED driver, e.g. commercial or residential lighting systems > 50 W
- Integrated electronic control gear for LED luminaires

Description

The LED Resonant controller ICL5101

is designed to control resonant converter topologies. The PFC stage operates in CrCM and DCM mode, supporting low load conditions. Integrated high and low side drivers assure a low count of external components, enabling small form factor designs.

ICL5101 parameters are adjusted by simple resistors only, this being the ideal choice to ease the design-in process. A comprehensive set of protection features ensures that the LED driver detects fault conditions, protecting both the LED driver and the LED load. Figure 1shows a typical application circuit of a 110 W constant voltage LED driver.

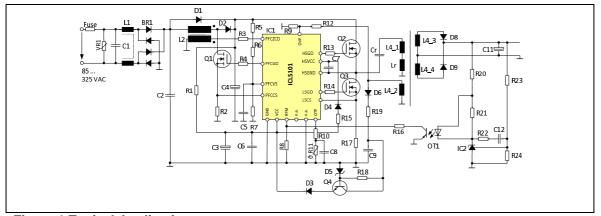


Figure 1 Typical Application

Product type	Package
ICL5101	PG-DSO-16-23



Table of Contents

Table of Contents

Resona	ant controller IC with PFC for LED driver	2
1	Pin Configuration and Description	
1.1	PG-DSO-16-23 Package	
1.2	PIN Configuration for PG-DSO-16-23	
1.3	PIN Set-Up	
1.4	PIN Functionality	
	•	
2 2.1	Functional DescriptionIntroduction	
2.1.1	UVLO to Soft Start	
2.1.1	Soft Start to Run Mode	
2.1.2	Detection Stage	
2.2 2.2.1	Detection of Over Temperature	
2.2.1	Detection of Output Overvoltage	
2.2.2		
2.2.3	Detection of Capacitive Mode Operation Surge Protection	
2.2.4	Self-Adapting Dead Time during Gate Drive Activity between HS and LS	10 17
2.2.6	Short Term Bus Under voltage	
2.2.7	Long-Term Bus Under voltage	
2.3	PFC Preconverter	
2.3.1	Operation Modes of the PFC Converter	
2.3.1	PFC Bus Overvoltage and Open Loop	
2.3.3	PFC Bus Voltage Levels 95 % and 75 %	
2.3.4	PFC Structure of Mixed Signals	
2.3.5	THD Correction via Zero Crossing Detection Signal	
2.4	State Diagram	
2.4.1	Monitoring of Features versus Operating Mode	26
2.4.2	Fault Condition – Flow Chart Fault F: Latch OFF after Single Restart	
2.4.3	Fault Condition – Flow Chart Fault A: Auto Restart	
2.4.4	Fault Condition – Flow Chart Fault U: BUS Voltage	
2.4.5	Protection Matrix	
3	Electrical Characteristics	24
3 .1	Absolute Maximum Ratings	
3.1	Operating Range	
3.3	Characteristics Power Supply Section	
3.4	Characteristics of PFC Section	
3.4.1	PFC Current Sense (PFCCS)	
3.4.2	PFC Zero Current Detection (PFCZCD)	
3.4.3	PFC Voltage Sensing Bus (PFCVS)	34
3.4.4	PFC PWM Generation	
3.4.5	PFC Gate Drive (PFCGD)	
3.5	Characteristics of Inverter Section	
3.5.1	Low-Side Current Sense (LSCS)	
3.5.2	Low-Side Gate Drive (LSGD)	
3.5.3	Inverter Minimum Run Frequency (RFM)	
3.5.4	Overtemperature Protection (OTP)	
3.5.5	Overvoltage Protection (OVP)	
3.5.6	High Side Gate Drive (HSGD)	
3.6	Timer Section	
4	Application Evenue	44
4 4.1	Application Example Schematic	
4.1	Scrematic	40
5	Outline Dimensions	41



The pin configuration is shown in Figure 2 and PIN Functionality Table 1. Short pin functionality is described below in 1.2.

1.1 PG-DSO-16-23 Package

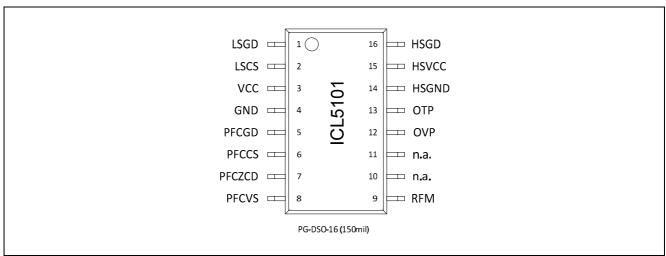


Figure 2 Pin Configuration

1.2 PIN Configuration for PG-DSO-16-23

Symbol	Pin	Function
LSGD	1	Low-side gate drive
LSCS	2	Low-side current sense signal
VCC	3	Chip supply voltage
GND	4	IC GND
PFCGD	5	PFC gate drive
PFCCS	6	PFC current sense signal
PFCZCD	7	PFC zero crossing detection
PFCVS	8	PFC voltage sensing
RFM	9	Set RUN frequency
n.a.	10	NOT APPLICABLE: Leave PIN OPEN
n.a.	11	NOT APPLICABLE: SET to GND
OVP	12	Overvoltage protection of secondary output
OTP	13	Over temperature protection
HSGND	14	High-side GND
HSVCC	15	High-side supply voltage
HSGD	16	High-side gate drive



1.3 PIN Set-Up

The PIN set-up of ICL5101 is shown in Figure 3.

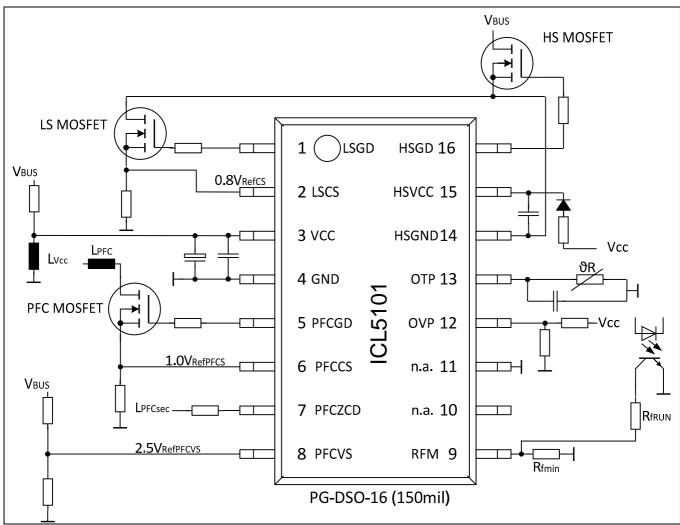


Figure 3 PIN Set-Up

The schematic in Figure 3 shows a typical PIN set-up for a PFC / LLC converter



1.4 PIN Functionality

Table 1. Pin Definitions and Functions

Symbol	Pin	Function
LSGD	1	Low-side gate drive The gate of the low-side MOSFET in a RESONANT inverter topology is
		controlled by this pin. There is an active L-level during UVLO (under voltage
		lockout) and a limitation of the max H-level at 11.0 V during normal
		operation. In order to turn on the MOSFET softly (with a reduced di _{DRAIN} /dt),
		the gate voltage rises typically within 245 ns from L-level to H-level. The fall
		time of the gate voltage is less than 50 ns in order to turn off quickly. This
		measure produces different switching speeds during turn-on and turn-off as it
		is usually achieved with a diode parallel to a resistor in the gate drive loop. It
		is recommended to use a resistor of typically 10 Ω between the drive pin and
		gate in order to avoid oscillations and in order to shift the power dissipation
		when discharging the gate capacitance into this resistor. The typical dead
		time between the LSGD signal and HSGD signal is self-adapting between
000		500 ns and 1.0 μs.
.SCS	2	Low-side current sense signal
		This pin is directly connected to the shunt resistor, which is located between
		the source terminal of the low-side MOSFET of the inverter and ground. Internal clamping structures and filtering measures allow sensing of the
		source current for the low side inverter MOSFET without additional filter
		components.
		There is a first threshold of 0.8 V. If this threshold is exceeded for longer
		than 500 ns during run mode, an inverter overcurrent is detected, which
		causes a latched shutdown of the IC. The saturation control is activated if the
		sensed slope at the LSCS pin reaches typical values of 205 mV/µs ±
		25 mV/µs and exceeds the 0.8 V threshold. The saturation regulator is now
		continuously monitored by the LSCS pin during saturation control mode. In
		saturation control mode, the regulator is designed to handle a choke
		operation in saturation. If the sensed current signal exceeds a second
		threshold of 1.6 V for longer than 500 ns before entering the run mode, the
		IC changes over into a latched shutdown.
		There are further thresholds active at this pin during run mode that detects capacitive mode operation. A voltage level below -50 mV before the high-
		side gate is on indicates faulty operation (operation below resonance).
		A second threshold at 2.0 V senses even short over currents during turn-on
		of the high-side MOSFET such as is typical for reverse recovery currents of
		a diode. If one of these comparator thresholds indicates incorrect operating
		conditions for longer than 620 µs in run mode, the IC turns off the gates and
		changes to fault mode due to detected capacitive mode operation (non-zero
		voltage switching).
		The threshold of -50 mV is also used to adjust the dead time between turn-
		off and turn-on of the RESONANT drivers in a range of 500 ns to 1.0 µs
		during all operating modes.
/CC	3	Chip supply voltage
		This pin provides the power supply of the ground-related section of the IC.
		There is a turn-on threshold at 14.0 V and a UVLO threshold at 10.6 V. The
		upper supply voltage level is 17.5 V. There is an internal Zener diode
		clamping V_{CC} at 16.3 V (at $I_{VCC} = 2 \text{ mA}$ typically). The maximum Zener current is internally limited to 5 mA. An external Zener diode is required for
		higher current levels. Current consumption during UVLO and during fault
		mode is less than 170 µA. A ceramic capacitor close to the supply and GND
		pin is required in order to act as a low-impedance power source for gate
		drive and logic signal currents. In the event of a short interruption to the
		mains supply, feed the start-up current (160 µA) from the bus voltage.



Symbol	Pin	Function
GND	4	IC GND
		This pin is connected to ground and represents the ground level of the IC for
		the supply voltage, gate drive and sense signals.
PFCGD	5	PFC gate drive
		The gate of the MOSFET in the PFC preconverter designed in boost
		topology is controlled by this pin. There is an active L-level during UVLO and
		a limitation of the max H-level at 11.0 V during normal operation. In order to
		turn on the MOSFET softly (with a reduced di _{DRAIN} /dt), the gate drive voltage
		rises within 245 ns from L-level to H-level. The fall time of the gate voltage is
		less than 50 ns in order to turn off quickly. A resistor of typically 10 Ω is
		recommended between the drive pin and gate in order to avoid oscillations
		and in order to shift the power dissipation when discharging the gate
		capacitance into this resistor. The PFC section of the IC controls a boost
		converter as a PFC preconverter in discontinuous conduction mode (DCM).
		Typically, the control starts with gate drive pulses with a fixed on-time of
		typically 4.0 µs at V _{ACIN} = 230 V, increasing up to 24 µs and with an off-time
		of 47 µs. As soon as sufficient zero current detector (ZCD) signals are
		available, the operation mode changes from fixed frequency operation to operation with variable frequency. The PFC works in critical conduction
		mode operation (CrCM) when rated and/or medium load conditions are
		present. That means triangular-shaped currents in the boost converter choke
		without gaps and variable operating frequency. During low load (detected by
		an internal compensator) we obtain operation with discontinuous conduction
		mode (DCM) – that means triangular-shaped currents in the boost converter
		choke with gaps when reaching the zero current level and variable operating
		frequency in order to avoid steps in the consumed line current.
PFCCS	6	PFC current sense signal
FF003		The voltage drop across a shunt resistor located between the source of the
		PFC MOSFET and GND is sensed with this pin. If the level exceeds a
		threshold of 1.0 V for longer than 200 ns, the PFC gate drive is turned off as
		long as the zero current detector (ZCD) enables a new cycle. If no ZCD
		signal is available within 52 µs after turn-off of the PFC gate drive, a new
		cycle is initiated from an internal start-up timer.
PFCZCD	7	PFC zero crossing detection
110200	'	This pin senses the point of time when the current through the boost inductor
		becomes zero during the off-time of the PFC MOSFET in order to initiate a
		new cycle.
		The moment of interest appears when the voltage of the separate ZCD
		winding changes from positive to negative level, which represents a voltage
		of zero at the inductor windings and therefore the end of current flow from
		the lower input voltage level to the higher output voltage level. There is a
		threshold with hysteresis, 1.5 V for increasing level, 0.5 V for decreasing
		level, which detects the change in inductor voltage. A resistor connected
		between the ZCD winding and PIN 7 limits the sink and source current of the
		sense pin when the voltage of the ZCD winding exceeds the internal
		clamping levels (typically 6.3 V and -2.9 V @ 5 mA) of the IC. If the sensed
		voltage level of the ZCD winding is not sufficient (e.g. during start-up), an
		internal start-up timer will initiate a new cycle every 52 µs after turn-off of the
		PFC gate drive. The source current out of this pin during the on-time of the
		PFC-MOSFET indicates the voltage level of the AC supply voltage. During
		low input voltage levels, the on-time of the PFC-MOSFET is enlarged in
		order to minimize gaps in the line current during zero crossing of the line
		voltage and improve the THD (Total Harmonic Distortion) of the line current.
		Optimization of the THD is possible by trimming of the resistor between this
		pin and the ZCD winding in combination with the inductance and used PFC
		MOSFET.



Symbol	Pin	Function
PFCVS	8	PFC voltage sensing
		The intermediate circuit voltage (bus voltage) at the smoothing capacitor is sensed by a resistive divider at this pin. The internal reference voltage for the rated bus voltage is 2.5 V. There are further thresholds at 0.3125 V (12.5 % of the rated bus voltage) for detection of open control loop and at 1.875 V (75 % of the rated bus voltage) for detection of under voltage, and at 2.725 V (109 % of the rated bus voltage) for detection of overvoltage. The overvoltage threshold operates with a hysteresis of 100 mV (4 % of the rated bus voltage). The bus voltage is sensed at 95 % (2.375 V) for detection of a successful start-up. It is recommended to use a small capacitor between this pin and GND as a spike suppression filter. In run mode, PFC overvoltage stops the PFC gate drive within 5 μ s. As soon as the bus voltage is less than 105 % of the rated level, the gate drives are enabled again. If the overvoltage lasts for longer than 625 ms, an inverter overvoltage is detected and turns off the inverter gate drives also. This causes a power-down and a power-up when $V_{\text{BUS}} < 109$ %. A bus under- $(V_{\text{BUS}} > 75$ %) or inverter overvoltage during run mode is handled as FAULT BUS. In this situation the IC changes to power-down mode and generates a delay of 100 ms with an internal timer. Then start-up conditions are checked and if valid, a further start-up is initiated. If start-up conditions are not valid, a further delay of 100 ms is generated. This procedure is repeated a maximum of seven times. If a start-up is successful within these seven cycles, the situation is interpreted as a short
RFM	9	interruption of the mains supply.
		A resistor from this pin to ground sets the operating frequency of the inverter during run mode. The typical run frequency range is 20 kHz to 120 kHz @ - 40°C and 130kHz @ - 25°C. The set resistor R_RFM can be calculated based on the run frequency f_{RFM} according to the equation: $R_{RFM} = \frac{5 \cdot 10^8 \Omega Hz}{f_{RUN}}$
	10	NOT Applicable: Leave PIN Open
n.a.	10	
n.a.	11	NOT Applicable: SET to IC GND as short as possible
OVP	12	Over voltage protection of OUTPUT Voltage In order to prevent overvoltage at the output stage – in the case of a floating LED –overvoltage protection at pin 12 can be activated. Use a resistor and a ceramic capacitor connected to the auxiliary winding in order to sense the voltage level at the auxiliary winding. During run mode, the auxiliary winding is monitored by a sensing current proportional to the auxiliary voltage. If the peak-to-peak voltage at this pin exceeds a threshold of 210 µApp for longer than 620 µs, overvoltage is detected. This function can be disabled by setting pin 12 to GND.
ОТР	13	Over temperature protection
		In order to prevent over temperature of the system, activate the over temperature protection at the OTP pin. Use a temperature-dependent resistor and a ceramic capacitor connected to GND for activation. There is a threshold of 3.2 V at the OTP pin during active run mode. If the voltage rises above this threshold for longer than 620 µs, the IC detects over temperature and changes to the latched fault mode. The latch mode is ended automatically by power-up or UVLO. This function can be disabled by setting pin 13 to GND.



Symbol	Pin	Function
HSGND	14	High-side GND This pin is connected to the source terminal of the high-side MOSFET, which is also the node of high-side and low-side MOSFET. This pin represents the floating ground level of the high-side driver and the high-side supply.
HSVCC	15	High-side supply voltage This pin provides the power supply of the high-side ground-related section of the IC. An external capacitor between pins 14 and 15 acts like a floating battery, which has to be recharged cycle by cycle via a high-voltage diode from the low-side supply voltage during the on-time of the low-side MOSFET. A UVLO threshold with hysteresis enables the high-side section at 10.4 V and disables it at 8.6 V.
HSGD	16	High-side gate drive The gate of the high-side MOSFET in an RESONANT inverter topology is controlled by this pin. There is an active L-level during UVLO and a limitation of the max H-level at 11.0 V during normal operation. The switching characteristics are the same as described for LSGD (pin 1). It is recommended to use a resistor of about 10 Ω between the drive pin and gate in order to avoid oscillations and in order to shift the power dissipation when discharging the gate capacitance into this resistor. The dead time between the LSGD signal and HSGD signal is self-adapting between 500 ns and 1.0 μ s (typically).



2 Functional Description

The functional description provides an overview of the integrated functions, features and their relationships. The parameters and equations provided are based on typical values at $T_A = 25$ °C. The corresponding minimum and maximum values are shown in the Electrical Characteristics.

2.1 Introduction

The ICL5101 is a high-performance mixed-signal controller for LED and SMPS applications. The IC is designed for a Power Factor Correction (PFC) close to 1, low THD below 5 %, a maximum efficiency up to 94 % PLUS and a minimal design-in phase due to use resistors only for setting up the IC. The IC is designed to working in ultra-wide and narrow range designs. Furthermore, all parameters are valid in an extended temperature range from $-40\,^{\circ}\text{C}$ up to 125 $^{\circ}\text{C}$ – especially frequency and timing. The controller utilizes a variety of protection features, including saturation control during start-up of the resonant converter, external adjustable over temperature, along with open and short load conditions. The ICL5101 includes also a surge protection feature, provides together with the CoolMOS technology a maximum protection against surges and safe components on board. Nevertheless CoolMOS P6 increases the efficiency by a 30% reduced gate charge and the internal gate resistor improves an easy use. For the half bridge is also a 500V CE CoolMOS recommended.



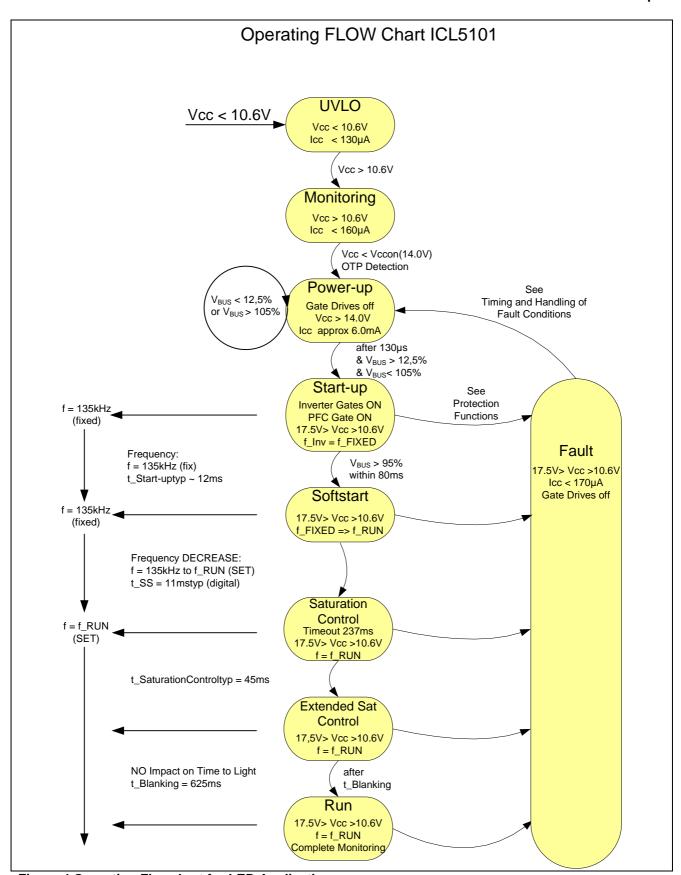


Figure 4 Operating Flowchart for LED Applications



Start-Up

The device is powered through the VCC pin. All device supply voltages are internally generated from VCC voltage. Typical Start-Up Procedure below Figure 5 shows a typical start-up procedure of the device. The following subsections describe the phases in detail.

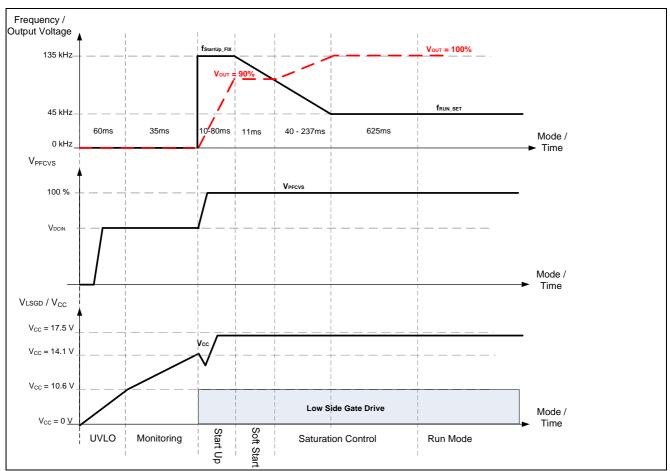


Figure 5 Typical Start-Up Procedure





2.1.1 UVLO to Soft Start

This section describes the operating flow from UVLO to soft start in detail — Start-Up Procedure from UVLO to Soft Start Figure 6. The control of the LED ballast is able to start the operation in less than 100 ms (Time to Light IC is in active mode). This is achieved by the low current consumption during UVLO (I_{VCC} = 130 μ A) and start-up hysteresis (I_{VCC} = 160 μ A — defines the start-up resistor) phases. The chip supply stage of the IC is protected against overvoltage via an internal Zener clamping network, which clamps the voltage at 16.3 V and allows a current of 2.5 mA. For clamping currents above 2.5 mA, an external Zener diode from VCC to GND is required.

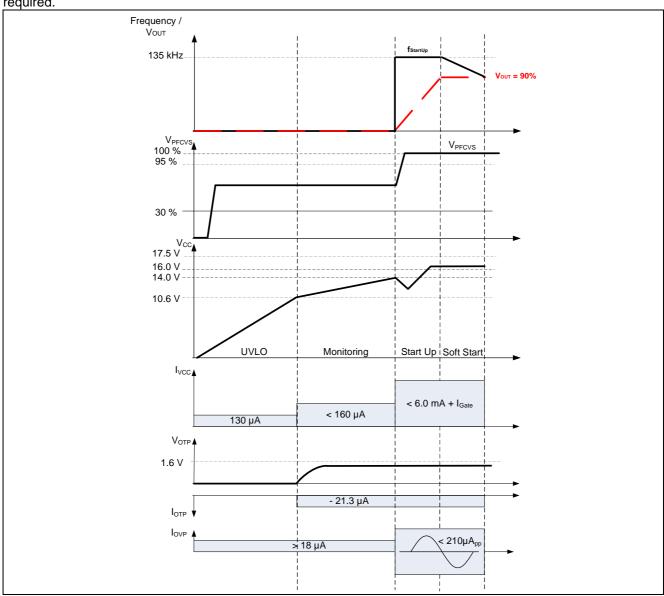


Figure 6 Start-Up Procedure from UVLO to Soft Start

If V_{CC} exceeds the 10.6 V level and stays below 14.0 V (start-up hysteresis), the IC checks whether the pcb temperature is experiencing over temperature or an output overvoltage is present. Over temperature is checked from a source current of typically I_{OTP3} = - 21.3 μ A out of pin 13 OTP (I_{OTP}). This current produces a voltage drop of V_{OTP} < 1.6 V (temperature is ok). Over temperature is detected if the voltage at the OTP pin exceeds the V_{OTP} > 1.6V threshold (V_{OTP}).

The output overvoltage is checked by a current of typically $I_{OVP} > 12 \mu A$ via resistors R12 into the OVP pin 12. Output overvoltage is detected if there is no sink current into the OVP pin. This causes a higher source current out of the OTP pin (typically 42.6 μA / 35.4 μA) in order to exceed $V_{OTP} > 1.6$ V. In the case of over temperature or overvoltage, the IC keeps monitoring until there is an adequate voltage from the OTP or OVP pin.



When V_{CC} exceeds the 14.0 V threshold – by the end of the start-up hysteresis – the IC waits for 80 μ s and senses the bus voltage. When the rated bus voltage is in the corridor of 12.5 % < $V_{BUSrated}$ < 105 %, the IC powers up. The IC initiates an UVLO when the chip supply voltage is below V_{CC} < 10.6 V. As soon as the condition of a power-up is fulfilled, the IC starts the inverter gate operation with an internal fixed start-up frequency of 135 kHz. The PFC gate drive starts with a delay of app. 300 μ s. Then the bus voltage will be checked for a rated level above 95 % for duration of 80 ms. Now, the IC enters the soft start phase and shifts the frequency from the internal fixed start-up frequency of 135 kHz down to the set RUN frequency.

2.1.2 Soft Start to Run Mode

This section describes the operating flow from soft start to run mode in detail. After the soft start phase is finished, the saturation control phase is entered.

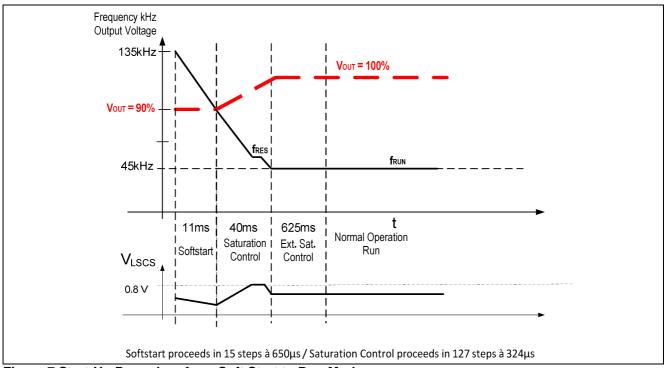


Figure 7 Start-Up Procedure from Soft Start to Run Mode

During saturation control (Start-Up Procedure from Soft Start to Run ModeFigure 7), the operating frequency of the inverter is shifted downward in t_{typ} = 40 ms to the run frequency set by a resistor at the pin RFM to GND. The saturation control is activated if the sensed slope at the LSCS pin reaches typically 205 mV/µs ± 25 mV/µs and exceeds the 0.8 V threshold. This stops the frequency decreasing and signifies waiting for an adequate output voltage. The saturation control is now continuously monitored by the LSCS pin. The maximum duration of the saturation control procedure is limited to 237 ms. If there is still saturation within this time frame, the saturation control is disabled and the IC changes over to the latched fault mode. Furthermore, in order to reduce the choke size, the saturation control is designed to operate with a choke in magnetic saturation of the RESONANT during start-up. For an operation in magnetic saturation during saturation control mode, the voltage at the shunt at the LSCS pin 2 has to be V_{LSCS} = 0.80 V when the output voltage is reached. If the saturation control mode is successfully passed, the IC enters the extended saturation mode The extended saturation mode is a safety mode used in order to prevent a malfunction of the IC due to an instable system. After 625 ms, the IC changes to the run mode (Figure 7). The run mode monitors the complete system regarding bus over- and under voltage, open loop, overcurrent of PFC and/or inverter, output overvoltage, over temperature and capacitive load operation.





2.2 Detection Stage

2.2.1 Detection of Over Temperature

Force a shut-off of the IC due to over temperature by using a PTC to GND on pin 13. In the event of an over temperature of the system (in run mode), the current out of the OTP pin 13 $I_{OTP3} = -21.3 \,\mu A$ charges up a capacitor. If the voltage at the OTP pin 13 exceeds the $V_{OTP3} = 3.2 V$ threshold, the controller detects an over temperature and stops the gate drives after a delay of $t = 620 \mu s$ set by an internal timer. The system restarts automatically. The possibility of a latch of the system is happen when it cools down and heat up within 200ms. When system is too hot before startup, the system prevents a power up.

2.2.2 Detection of Output Overvoltage

Overvoltage is detected by measuring the peak levels of the voltage at the AUX winding via an AC current fed into the OVP pin 12. If the sensed AC current exceeds 210 μA_{PP} for longer than 620 μs , the status of overvoltage is detected. The OVP fault results in a latched power-down mode (after trying a single restart). The controller continuously monitors the status until the overvoltage status changes.

2.2.3 Detection of Capacitive Mode Operation

RESONANT converter designs should avoid working in capacitive mode operation – not even under abnormal conditions. ICL5101 provides capacitive mode operation detection and latch-off of the system after a single restart for error verification. Resonant converters work in capacitive mode when their switching frequency falls below a critical value. This depends on the loading condition and the input-to-output ratio. They are especially prone to enter capacitive mode when the input voltage is lower than the minimum specified and/or the output is overloaded or shorted. In order to prevent a malfunction in the area of capacitive load during run mode due to certain deviations from the normal load, the IC senses only via the LSCS pin 2.

Capacitive load operation is detected if the voltage at the LSCS pin drops below a first threshold of $V_{LSCSCap1} = -50$ mV directly before the high-side MOSFET is turned on or exceeds a second threshold of $V_{LSCSCap2} = 2.0$ V during ON switching of the high-side MOSFET (Figure 8). If this overcurrent is present for longer than 620 μ s, the IC results a latched power-down mode after trying a single restart.

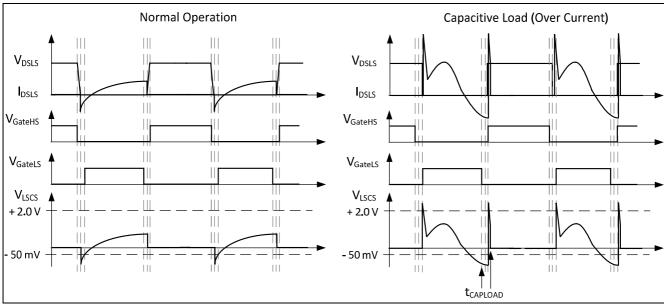
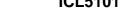


Figure 8 Capacitive Mode Operation





2.2.4 **Surge Protection**

Description SURGE Protection

In case of a surge event, the voltage at the BUS capacitors C5 & C8 rises up, the driver stages of the ICL5101 are shut off when VLscs > 0.8V and VBUS > 109% for longer than 500ns. After the surge the controller restarts automatically when V_Bus drops below 109% of the rated voltage. This feature allows driving 500V MOSFETs at the half bridge stage when adequate EMI and DC LINK networking is present. For an effective protection use CooMOSTM technology.

SURGE Detection

If the bus voltage exceeds:

VBUS > 109%

and the voltage at the low side current sense pin 2 exceeds:

 $V_{LSCS} > 0.8V$

for longer than

t = 500 ns

SURGE Protection

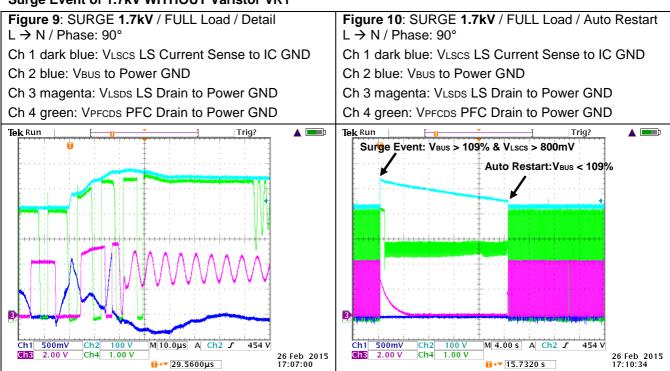
All Gate Drives OFF

Auto Restart:

VBUS < 109%

Measurement

Surge Event of 1.7kV WITHOUT Varistor VR1





2.2.5 Self-Adapting Dead Time during Gate Drive Activity between HS and LS

The dead time between the turn OFF and turn ON of the RESONANT drivers is self-adapting and is detected by means of switch-off of the high-side MOSFET and the –50 mV threshold of the LSCS voltage (see Figure 11). The typical range of the dead time adjustment is 500 ns up to 1.0 µs during all operating modes. The start of the dead time measurement is the OFF switching of the high-side MOSFET. The dead time measurement finishes when V_{LSCS} drops below -50 mV for longer than typically 300 ns (internal fixed propagation delay). This time will be stored, the low-side gate driver switches ON. The high-side gate driver turns ON again after OFF switching of the low-side switch and the stored dead time (see copied dead time in Figure 11).

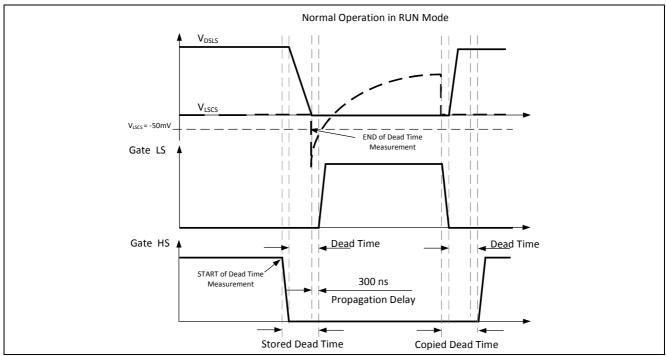


Figure 11 Dead Time ON and OFF of the Inverter Gate Drivers



2.2.6 Short Term Bus Under voltage

Short-term PFC bus under voltage (Figure 12) is detected if the duration of the under voltage does not exceed 800 ms (timer remains below t < 800 ms). In this case, the PFC and inverter drivers are immediately switched off and the controller continuously monitors the status of the bus voltage in a latched power-down mode (I_{CC} < 170 μ A). If the signal at the OVP PIN exceeds 18 μ A and the rated bus voltage is above 12.5 % while the timer is below t < 800 ms, the controller restarts from power-up. The timer resets to 0 when entering the run mode.

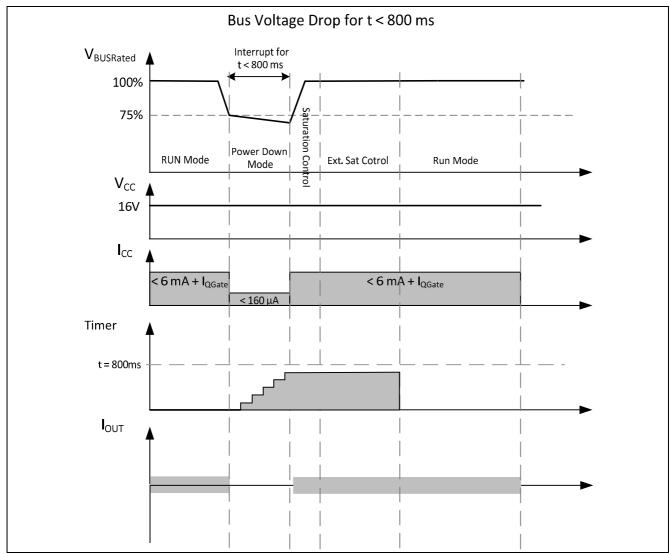


Figure 12 Bus Under voltage - Short



2.2.7 Long-Term Bus Under voltage

If the bus under voltage exceeds t > 800 ms (Figure 13) the controller forces an under voltage lock-out (UVLO). The chip supply voltage drops below V_{CC} = 10.6 V and the chip supply current is below I_{CC} < 130 μ A. When the Vcc voltage exceeds the 10.6 V threshold again, the IC current consumption is below I_{CC} < 160 μ A. In this case, the controller resets the timer and restarts with the full start-up procedure, including monitoring, power-up, start-up, soft start, saturation control, extended saturation mode and run mode.

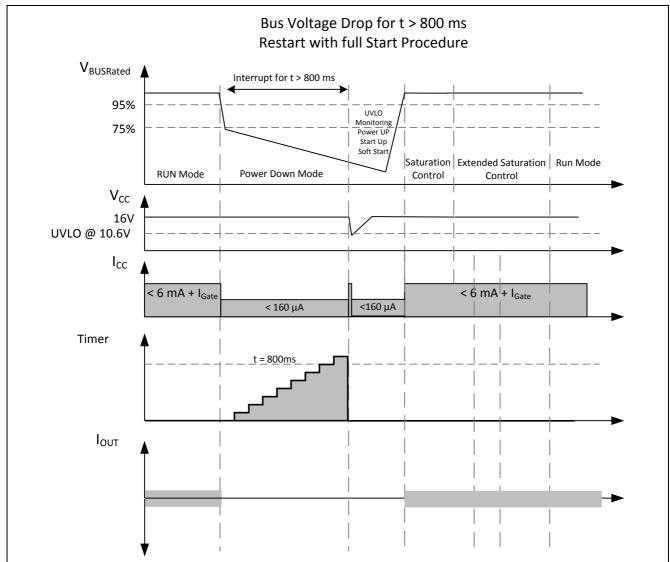


Figure 13 Bus Under voltage - Long



2.3 PFC Preconverter

2.3.1 Operation Modes of the PFC Converter

The digitally controlled PFC pre-converter starts with an internally fixed ON time of typically $t_{ON} = 4.0 \mu s$ and variable frequency. The ON time is increased every 280 μs (typical) up to a maximum ON time of 24 μs . The control switches quite immediately from discontinuous conduction mode (DCM) to critical conduction mode (CrCM) as soon as a sufficient ZCD signal becomes available. The frequency range in CrCM is 22 kHz up to 500 kHz, depending on the power (Figure 14) with a variation in the ON time of 24 $\mu s > t_{ON} > 0.5 \mu s$.

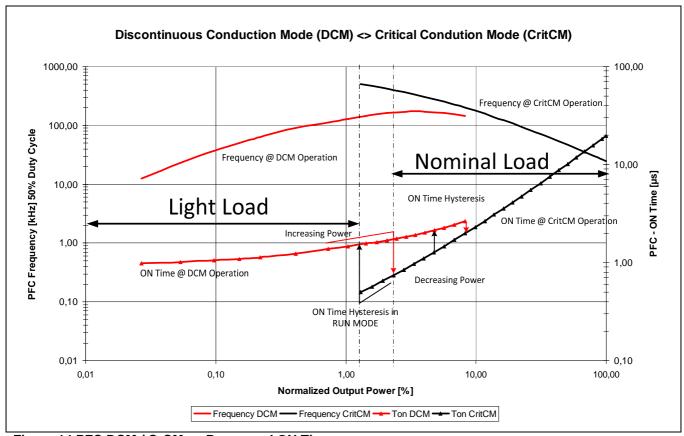


Figure 14 PFC DCM / CrCM vs Power and ON Time

For lower loads (P_{OUTNorm} < 8 % of the normalized load¹) the controller operates in discontinuous conduction mode (DCM) with an ON time of 4.0 µs and increasing OFF time. The frequency during DCM is variable in a range from 144 kHz down to typically 22 kHz @ 0.1 % load. With this control method, the PFC converter enables stable operation from a 100 % load down to 0.1 %. Figure 14 shows the ON time range in DCM and CrCM (Critical Conduction Mode) operation. In the overlapping area of CrCM and DCM there is a hysteresis of the ON time, which causes a negligible frequency change.

Datasheet 20 Rev. 1.3, 2016-01-15

¹ Normalized Power @ Low Line Input Voltage and maximum Lload



2.3.2 PFC Bus Overvoltage and Open Loop

The bus voltage loop control is completely integrated (Figure 15) and provided by an 8-bit sigma-delta A/D converter with a typical sampling rate of 280 μ s and a resolution of 4 mV/bit. After leaving monitoring, the IC starts to power up (Vcc > 14.0 V). After power-up, the IC senses the bus voltage below 12.5 % (open loop) or above 105 % (bus overvoltage) for 80 μ s – 130 μ s. In the case of bus overvoltage (V_{BUSrated} > 109 %) or open loop (V_{BUSrated} < 12.5 %), the IC shuts off the gate drives of the PFC within 5 μ s or 1 μ s respectively. In this case, the PFC restarts automatically when the bus voltage is within the corridor (12.5 % < V_{BUSrated} < 105 %) again. If the bus voltage is valid after the 130 μ s, the bus voltage sensing is set to 12.5 % < V_{BUSrated} < 109 %. If these thresholds are departed from for longer than 1 μ s (open loop) or 5 μ s (overvoltage), the PFC gate drive stops working until the voltage drops below 105 % or exceeds the 12.5 % level. If the bus overvoltage (> 109 %) lasts for longer than 625 ms in run mode, the inverter gates also shut off and a power-down with complete restart is attempted (Figure 15).

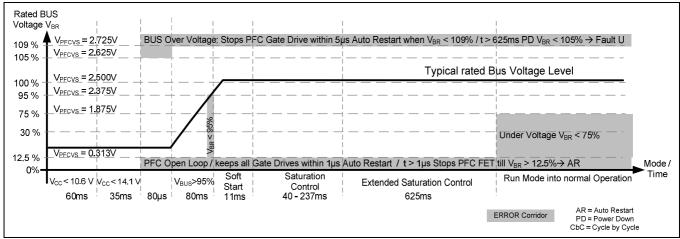


Figure 15 PFC Bus Voltage Operating and Error Levels

2.3.3 PFC Bus Voltage Levels 95 % and 75 %

When the rated bus voltage is in the corridor of 12.5 % < $V_{BUSrated}$ < 109 %, the IC will check whether the bus voltage exceeds the 95 % threshold (Figure 15) within 80 ms before entering soft start phase. Another threshold is activated when the IC enters the run mode. If the rated bus voltage drops below 75 % for longer than 84 μ s, a power-down with a complete restart is attempted if a counter exceeds 800 ms. In the case of short-term bus under voltage (the bus voltage reaches its working level in run mode before exceeding typically 800 ms - min. 500 ms) the IC skips phases and starts up directly in saturation control. The internal reference level of the bus voltage sense V_{PFCVS} is 2.5 V (100 % of the rated bus voltage) with a high accuracy. Surge protection is activated in the case of a rated bus voltage of V_{BUS} > 109 % and a low-side current sense voltage of V_{LSCS} > 1.6 V in extended saturation mode or of V_{LSCS} > 0.8 V in run mode for longer than 500 ns in RUN Mode.



2.3.4 PFC Structure of Mixed Signals

A digital NOTCH filter eliminates the input voltage ripple independent of the mains frequency. A subsequent error amplifier with PI characteristic ensures stable operation of the PFC pre-converter (Figure 16)

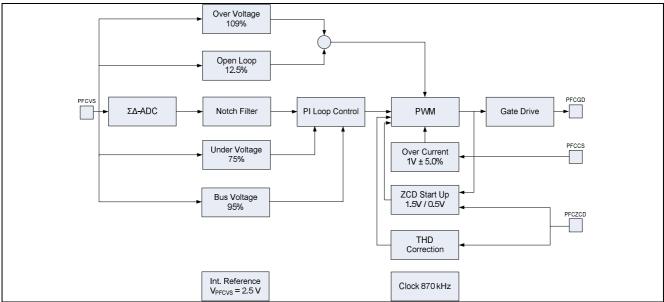


Figure 16 PFC Mixed Signal Structure

The zero current detection (ZCD) is sensed by the PFC ZCD. Indication of finished current flow during demagnetization is required in CrCM and in DCM as well. The input is equipped with a special filtering, including an extended saturation of typically 500 ns and a large hysteresis of typically V_{PFCZCD} between 0.5 V and 1.5 V.



2.3.5 THD Correction via Zero Crossing Detection Signal

An additional feature is the THD correction (Figure 17). In order to optimize the THD (especially in the zones A shown in Figure 17, ZCD @ AC input voltage), there is a possibility to extend the pulse width of the gate signal (blue part of the PFC gate signal) via the variable PFC ZCD resistor from the ZCD pin to the PFC choke in addition to the gate signal controlled by the V_{PECVS} signal (gray part of the PFC gate signal).

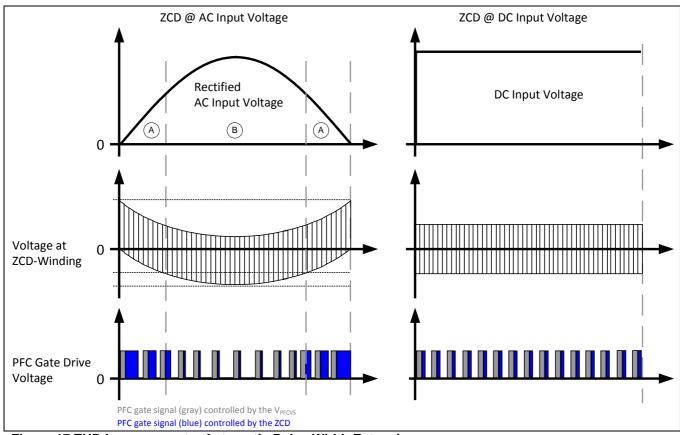


Figure 17 THD Improvement – Automatic Pulse Width Extension

In the case of DC input voltage, the pulse width gate signal is fixed as a combination of the gate signal controlled by the V_{PFCVS} pin (gray) and the additional pulse width signal controlled by the ZCD pin (blue) ZCD @ DC input voltage.

The PFC current limitation at pin PFCCS interrupts the ON time of the PFC MOSFET if the voltage drop at the PFC shunt resistors exceeds $V_{PFCCS} = 1.0 \text{ V}$. This interrupt will restart after the next sufficient signal from ZCD becomes available (auto restart). The first value of the resistor can be calculated as the ratio of the PFC mains choke and ZCD winding times the bus voltage to a current of typically 1.5 mA (Equation 1). An adjustment of the ZCD resistor causes an optimized THD.

$$R_{ZCD} = \frac{\frac{N_{ZCD}}{N_{PFC}} * V_{BUS}}{1.5 mA}$$

Equation 1: R_{ZCD} - A Good Practical Value





THD Adujstment

Introduction:

In order to provide an excellent THD result, the THD of the ICL5101 is adjustable. Especially at high line input voltage and low load condition, the THD is a critical value. It doesn't matter in which condition:

- Line input voltage
- Stable load
- Load variation

the ICL5101 is providing best results for all cases – only by trimming a resistor R3 see Figure 18.

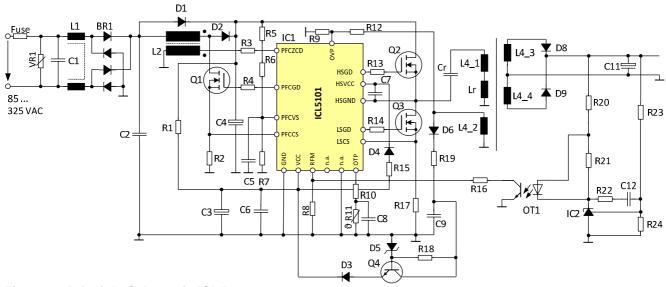


Figure 18 Principle Schematic ICL5101

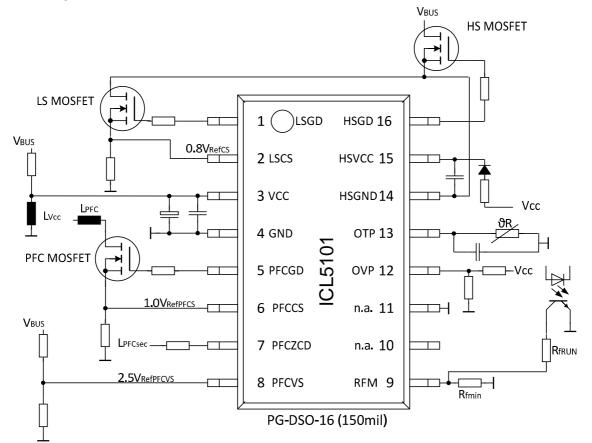


Figure 19 PIN SetUP ICL5101



How to do:

To improve the THD the resistor – see R3 Figure 18 or red signed resistor in Figure 19 – at ZCD PIN 7 can be trimmed to an optimal value (several k-ohm ~ 20 up to 100k) in order to reach best THD results.

Step one is to define the inductivity of the PFC choke and the MOSFET. After fixing PFC choke and transistor, two scenarios are happen:

1/ operation in stable load condition e.g. lamp ON / OFF

SET nominal load condition and vary the value of the resistor until you get the best THD results. Outcome sees Figure 20 black curve

2/ operation with load variation e.g. dimming of an LED

Choose a resistor and vary the load. Change value up or down in order to get your best result over the whole load range – outcome sees Figure 20 red curve.

Mechanism:

The controller operates in two modes:

- Critical Conduction Mode (CrCM) in a wide load range
- Wait Cycle Mode (WCM a kind of DCM) for low load

Switch from CrCM into WCM):

The ICL5101 has an integrated logic which can be regulated via the resistor at the ZCD PIN 7 in varying the value of the resistor.

Limit:

The digital logic of the controller is limited. At high line input voltages, the controller reduces the ON time of the PFC gate driver. If the minimum ON time is reached – physically given by the internal digital stage – the controller switches over from the critical conduction mode CrCM into the wait cycle mode WCM. This switch over can be seen in the THD measurement shown in Figure 20 black curve. Depending on the load (stable or variable) the optimum configuration can be found as shown in Figure 20 red curve. This effect can be prevented by trimming the resistor at the ZCD PIN 7 – lower the resistance leads to a smother cross over from CrCM into WCM (red curve) but increases slightly the THD.

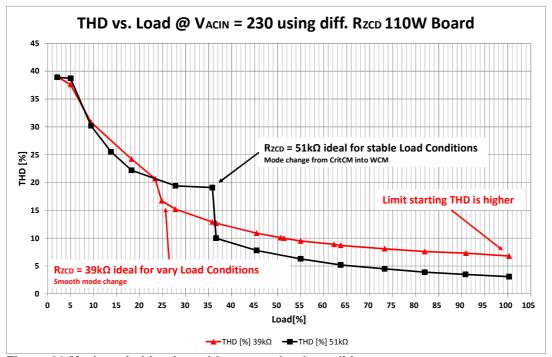


Figure 20 Mode switching in stable or vary load condition



2.4 State Diagram

2.4.1 Monitoring of Features versus Operating Mode

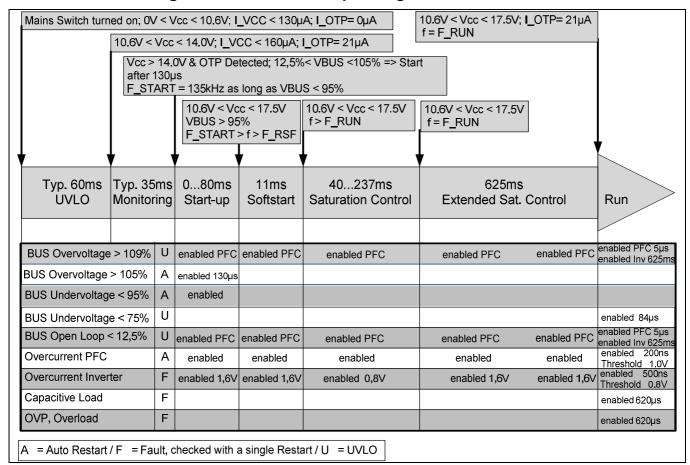


Figure 21 Monitoring of Features versus Operation Mode





2.4.2 Fault Condition – Flow Chart Fault F: Latch OFF after Single Restart

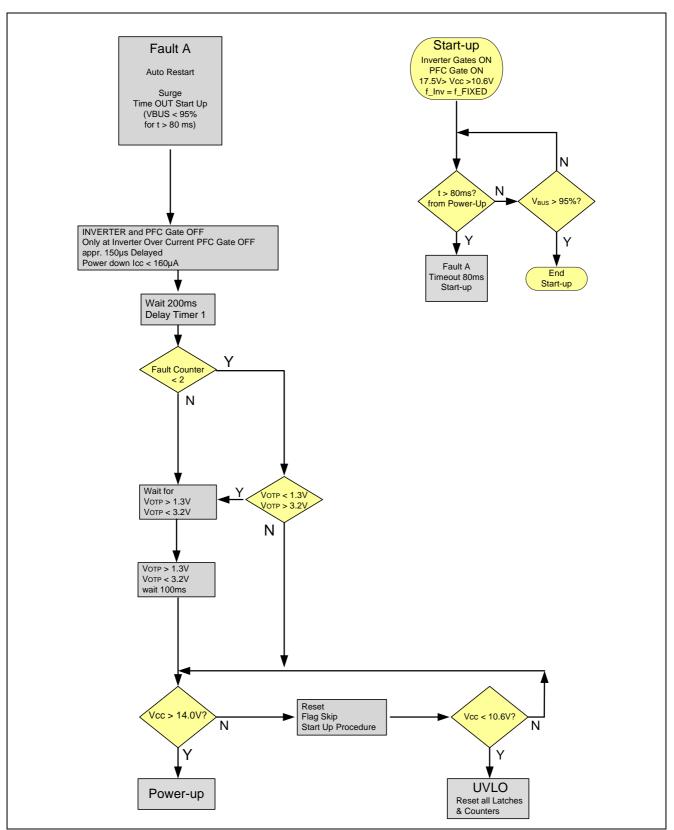


Figure 22 Fault Condition F – Latch OFF after Single Restart



2.4.3 Fault Condition – Flow Chart Fault A: Auto Restart

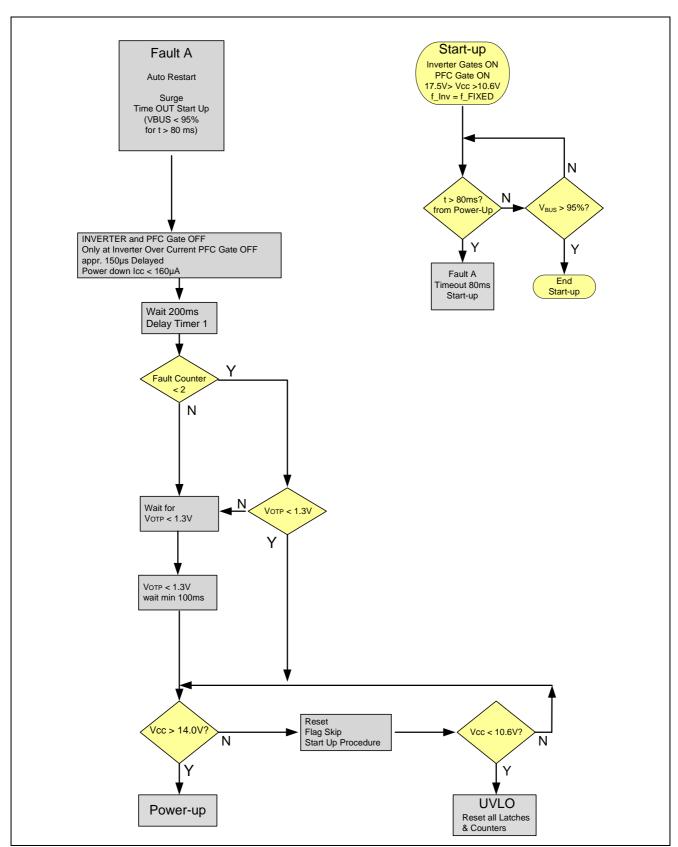


Figure 23 Fault Condition A – Auto Restart





2.4.4 Fault Condition – Flow Chart Fault U: BUS Voltage

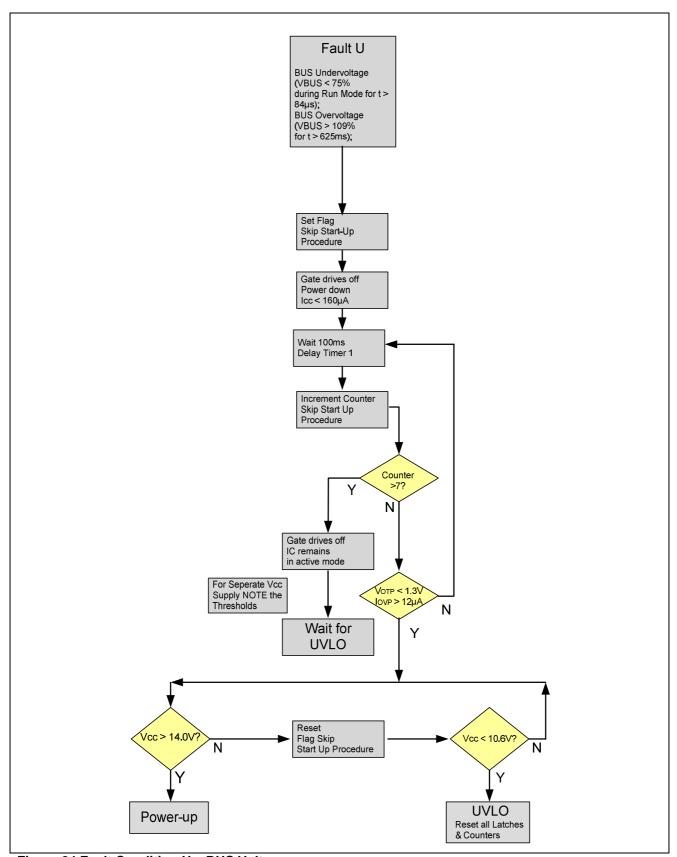


Figure 24 Fault Condition U – BUS Voltage



2.4.5 Protection Matrix

Bus voltage < 12.5% Open loop detection of rated level Bus voltage < 12.5% Shutdown option of rated level Bus voltage < 12.5% Shutdown option of rated level Bus voltage < 12.5% Shutdown option of rated level Bus voltage < 75% Of rated level add. shut down delay 120µs Bus voltage < 95% of rated level and shut down delay 120µs Bus voltage < 95% of rated level during start-up start-up time Bus voltage > 105% of rated level during start-up time Bus voltage > 105% of rated level of ups after power up Bus voltage > 109% of rated level of ups after power up Bus voltage > 109% of rated level of ups after power up Bus voltage > 109% of rated level of output voltage at Piro VP above threshold Capacitive Load operation below resonance Voltage at PFCCS pin > 1.0V Voltage at LSCS pin > 0.8V New root and rever power up Voltage at LSCS pin > 0.8V New root and rever power up Voltage at LSCS pin > 0.8V New root and rever power up Voltage at LSCS pin > 0.8V New root and rever power up Voltage at LSCS pin > 0.8V New root and rever power up Voltage at LSCS pin > 0.8V New root and rever power up Voltage at LSCS pin > 0.8V New root and rever power up Voltage at LSCS pin > 0.8V New root and rever power up Voltage at LSCS pin > 0.8V New root and rever power up Voltage at LSCS pin > 0.8V New root and rever power up Voltage at LSCS pin > 0.8V New root and rever power up Voltage at LSCS pin > 0.8V New root and rever power up Voltage at LSCS pin > 0.8V New root and rever power up New root and reversal r	Description of Fault	Characteristics of Fault				Operating Mode Detection is active						Consequence
before power up Supply voltage Vcc < 10.6V Alter power up Supply voltage Vcc < 10.6V Alter power up Voltage at OTP pin > 1.6V before power up Voltage at OTP pin > 3.2V Overtemperature Voltage at OTP pin > 3.2V Overtemperature F 620µs Supply voltage × 12.5% of rated level 10µs after power up Alter power up Voltage × 12.5% of rated elevel Bus voltage × 12.5% Open loop detection Sus voltage × 19.5% of rated level during start-up Bus voltage × 19.5% of rated level during start-up Bus voltage × 19.5% of rated level during start-up Bus voltage × 19.5% of rated level flous after power up Bus voltage × 19.5% of rated level flous after power up Bus voltage × 19.5% of rated level in active operation Bus voltage × 19.5% of rated level of output voltage at Pin OVP above threshold Capacitive Load operation below resonance Voltage at LSCS pin > 0.8V Inverter voltage × 19.5% of rated level at LSCS pin > 0.8V Inverter voltage × 19.5% of rated level at LSCS pin > 0.8V Inverter voltage × 19.5% of rated level at SCS pin > 0.8V Inverter voltage × 19.5% of rated level in active operation Voltage at LSCS pin > 0.8V Inverter voltage × 19.5% of rated level in active operation Voltage at LSCS pin > 0.8V Inverter voltage × 19.5% of rated level in active operation Voltage at LSCS pin > 0.8V Inverter voltage × 19.5% of rated level in active operation Voltage at LSCS pin > 0.8V Inverter voltage × 19.5% of rated level in active operation Voltage at LSCS pin > 0.8V Inverter voltage × 19.5% of rated level in active operation Voltage at LSCS pin > 0.8V Inverter voltage × 19.5% of rated level in active operation Voltage at LSCS pin > 0.8V Inverter volt		Name of fault	•	Minimum duration of effect	Monitoring	Power-up 130µs	Start-up until VBUS > 95%	Softstart 11ms	Saturation control 40 ms typ.	Ext. Sat. Con. 625ms	Run mode	
after power up threshold			S	1µs	X							Prevents power up
before power up Voltage at OTP pin > 3.2V Voltage at OTP pin > 3.2V Overtemperature F 620µs Bus voltage < 12.5% of rated level flups after power up detection of rated level 10µs after power up Bus voltage < 12.5% Open loop detection Open loop detection of rated level Bus voltage < 12.5% Shutdown option of rated level Bus voltage < 12.5% Shutdown option of rated level Bus voltage < 75% of rated level Bus voltage < 95% of rated level of upto voltage Bus voltage > 109% of rated level in active operation Bus voltage > 109% of rated level in active operation Bus voltage > 109% of rated level in active operation PEFC overvoltage Bus voltage > 109% of rated level of output voltage at Pin OVP above threshold Operation below resonance Voltage at LSCS pin > 1.0V Voltage at LSCS pin > 1.8V Inverter F 500ns Ar 100 No Fault Voltage at LSCS pin > 0.8V Voltage at LSCS pin > 0.8V Voltage at LSCS pin > 0.8V Inverter F 500ns Ar 200 No Fault Voltage at LSCS pin > 0.8V Voltage at	Supply voltage Vcc < 10.6V after power up	threshold	S	5µs	X	X	Х	Х	Х	Х	X	
Bus voltage < 12.5% of rated level 10µs after power up detection Bus voltage < 12.5% of pen loop detection Bus voltage < 12.5% of pen loop of rated level detection Bus voltage < 12.5% of pen loop detection Bus voltage < 12.5% of pen loop detection Grated level detection Bus voltage < 12.5% of pen loop detection Bus voltage < 75% of loop detection Bus voltage < 75% of rated level Bus voltage < 95% of rated level during start-up Bus voltage > 105% of rated level during start-up time Bus voltage > 105% of rated level active operation Bus voltage > 109% of rated level active operation Bus voltage > 109% of rated level active operation Bus voltage > 109% of rated level active operation Bus voltage > 109% of rated level in active operation Bu		Overtemperature	S	100µs	X							Prevents power up
Investigation Investigatio	Voltage at OTP pin > 3.2V	Overtemperature	F	620µs							X	fault mode, 1 restart
of rated level Bus voltage < 12.5% Grated level Bus voltage < 75% Grated level Bus voltage < 75% Grated level Bus voltage < 95% of rated level Bus voltage > 105% of rated level in active operation Bus voltage > 109% of rated level in active operation Bus voltage > 109% of rated level in active operation Bus voltage > 109% of rated level in active operation Bus voltage > 109% of rated level in outline operation Bus voltage > 109% of rated level in outline operation Bus voltage > 109% of rated level in active operation Bus voltage > 109% of rated level in outline operation Bus voltage > 109% of rated level in outline operation Bus voltage > 109% of rated level in outline operation Bus voltage > 109% of rated level in outline operation Bus voltage > 109% of rated level in outline operation Bus voltage > 109% of rated level in outline operation Bus voltage > 109% of rated level in outline operation Bus voltage > 109% of rated level in outline operation Bus voltage > 109% of rated level in outline operation Bus voltage > 109% of rated level in outline operation Bus voltage > 109% of rated level in outline operation Bus voltage > 109% of rated level in outline operation Bus voltage > 109% of rated level in outline operation Bus voltage > 109% of rated level in outline operation Bus voltage > 109% of rated level in outline operation Bus voltage > 109% of rated level in outline operation below resonance Voltage at LSCS pin > 0.8V Voltage at LSCS pi	level 10µs after power up	detection		1µs		X						start after Vcc hysteresis
of rated level Bus voltage < 75% of rated level add. shut down delay 120µs Bus voltage > 95% of rated level grant per level 10µs after power up Bus voltage > 105% of rated level 10µs after power up Bus voltage > 105% of rated level 10µs after power up Bus voltage > 109% of rated level 10µs after power up Bus voltage > 109% of rated level in active operation Bus voltage > 109% of rated level in active operation Bus voltage > 109% of rated level in oactive operation Bus voltage > 100% of rated level in oactive operation Bus voltage > 100% of rated level in oactive operation Bus voltage > 100% of rated level in oactive operation Bus voltage > 100% of rated level in oactive operation level in oact	of rated level	detection	N	1µs			X	X	X	X	X	VBUS > 12.5%
of rated level add. shut down delay 120µs Bus voltage < 95% of rated level during start-up Bus voltage > 105% of rated level during start-up Bus voltage > 105% of rated level 10µs after power up Bus voltage > 105% of rated level 10µs after power up Bus voltage > 109% of rated level in active operation Bus voltage > 109% of rated level in active operation Bus voltage > 109% of rated level in active operation Bus voltage > 109% of rated level in active operation Bus voltage > 109% of rated level in active operation Bus voltage > 109% of rated level in active operation Bus voltage > 109% of rated level in active operation PFC overvoltage U 625ms During F 620µs T Power down, restart when VBUS<105% Power down, latched fault mode, 1 restart Voltage at PFCCS pin > 1.0V Voltage at LSCS pin > 0.8V Nover down, latched fault mode, 1 restart Voltage at LSCS pin > 0.8V Nover down, latched fault mode, 1 restart Voltage at LSCS pin > 0.8V Nover down, latched fault mode, 1 restart Voltage at LSCS pin > 0.8V Nover down, latched fault mode, 1 restart Voltage at LSCS pin > 0.8V Nover down, latched fault mode, 1 restart Volt	of rated level	•	U								X	when VBUS> 12.5%
Level during start-up Start-up time Start-up condition, N = No fault, Start-up condition, N = No fault, Start-up condition, N = No fault, Start-up condition, Start-up time Start-up condition, Start-up time Start-up condition, Start-up condi	of rated level	Under voltage	U	84µs							X	,
Level 10µs after power up Start after Vcc hysteresis	level during start-up	start-up time					X					delay, restart
Inverter	level 10µs after power up	•		-		Х						start after Vcc hysteresis
In active operation Overvoltage Output O	level in active operation						Х	Х	Х	Х		VBUS< 105%
at Pin OVP above threshold overvoltage Capacitive Load operation below resonance Voltage at PFCCS pin > 1.0V Voltage at LSCS pin > 0.8V Noltage at LSCS pin > 0.8V Voltage at LSCS pin > 0.8V Voltage at LSCS pin > 0.8V Noltage at LSCS pin > 0.8V Voltage at LSCS pin > 0.8V Noltage at LSCS pin > 0.8V Voltage at LSCS pin > 0.8V V	level in active operation	overvoltage										when VBUS<105%
operation below resonance N 200ns X <t< td=""><td>at Pin OVP above threshold</td><td>overvoltage</td><td></td><td></td><td></td><td></td><td></td><td></td><td></td><td></td><td></td><td>fault mode, 1 restart</td></t<>	at Pin OVP above threshold	overvoltage										fault mode, 1 restart
Voltage at LSCS pin > 0.8V Inverter current lim Voltage at LSCS pin > 1.2V Saturation Time OUT Voltage at LSCS pin > 0.8V Time OUT Voltage at LSCS pin > 0.8V Ext. Sat. Time OUT Voltage at LSCS pin > 0.8V Ext. Sat. Time OUT Voltage at LSCS pin > 0.8V Ext. Sat. Time OUT Voltage at LSCS pin > 0.8V Inverter overcurrent Voltage	operation below resonance											fault mode, 1 restart
current lim Voltage at LSCS pin > 1.2V		overcurrent					Х	Х		Х	Х	FET immediately
& 205mV/µs Slope in 0.8V Time OUT Voltage at LSCS pin > 0.8V Ext. Sat. Time OUT Voltage at LSCS pin > 0.8V Inverter overcurrent Voltage at LSCS pin > 1.6V Inverter overcurrent Voltage at LSCS pin > 0.8V Inverter overcurrent Voltage at LSCS pin > 1.6V Inverter overcurrent Voltage at LSCS pin > 0.8V Inverter overcurrent A 500ns Inverter overcurrent overcurrent overcurrent overcurrent overcurrent A 500ns Inverter overcurrent over		current lim										saturation control
& 205mV/µs Slope OUT Inverter overcurrent F 500ns X X X Power down, latched fault mode, 1 restart Voltage at LSCS pin > 1.6V Inverter overcurrent F 500ns X X X X X X Power down, latched fault mode, 1 restart Voltage at LSCS pin > 0.8V Inverter overcurrent A 500ns X X X X Power down, latched fault mode, 1 restart Voltage at LSCS pin > 0.8V Inverter overcurrent A 500ns X X X Power down, restart & VBUS > 109% (Surge) overcurrent overcurrent A 500ns X X X X Power down, latched fault mode, 1 restart & VBUS > 109% (Surge) overcurrent overcurrent A 500ns X X X X Power down, latched fault mode, 1 restart & VBUS > 109% (Surge) overcurrent overcurrent A 500ns X X X X Power down, restart & VBUS > 109% (Surge) Overcurrent A 200ms A single restart attempt after delay of internal timer Reset of failure latch by UVLO or 40s in run	& 205mV/µs Slope in 0.8V	Time OUT							Х			fault mode, 1 restart
Voltage at LSCS pin > 1.6VInverter overcurrentF500nsXXX<	& 205mV/µs Slope	OUT								Х	.,	fault mode, 1 restart
Voltage at LSCS pin > 0.8V & VBUS > 109% (Surge) Inverter overcurrent A boons overcurrent A boons overcurrent X construction X construction<		overcurrent									Х	fault mode, 1 restart
& VBUS > 109% (Surge) overcurrent A A when VBUS<109% After jump into latched fault mode F wait 200ms A single restart attempt after delay of internal timer Reset of failure latch in run mode after 40s Reset of failure latch by UVLO or 40s in run mode S = Start-up condition, N = No fault, A = Auto restart, U = Under voltage		overcurrent					Х	Х	Х		.,	fault mode, 1 restart
Reset of failure latch in run mode after S = Start-up condition, N = No fault, A = Auto restart, U = Under voltage	& VBUS > 109% (Surge) overcurrent				when VBUS<109%					when VBUS<109%		
S = Start-up condition, N = No fault, A = Auto restart, U = Under voltage												
F = Fault with a single restart, a second F leads to a latched fault / Note: all values @ typical 50 Hz mains frequency												





Note: All voltages without the high-side signals are measured with respect to ground (pin 4). The high-side voltages are measured with respect to pin 17. The voltage levels are valid if other ratings are not violated.

3.1 Absolute Maximum Ratings

Note: Absolute maximum ratings are defined as ratings, which if exceeded may lead to destruction of the integrated circuit. For the same reason make sure that any capacitor connected to pin 3 (VCC) and pin 18 (HSVCC) is discharged before assembling the application circuit.

Parameter	Symbol	Limit \	Values	Unit	Remarks
		min.	max.		
LSCS Voltage	V _{LSCS}	- 5	6	V	
LSCS Current	I _{LSCS}	- 3	3	mA	
LSGD Voltage	V_{LSGD}	- 0.3	V _{cc} +0.3	V	Internally clamped to 11V
LSGD Peak Source Current	I _{LSGDsomax}	- 75	5	mA	< 500 ns
LSGD Peak Sink Current	I _{LSGDsimax}	- 50	400	mA	< 100 ns
VCC Voltage	V _{vcc}	- 0.3	18.0	V	
VCC Zener Clamp Current	I _{VCCzener}	- 5	5	mA	IC in Power Down Mode
PFCGD Voltage	V_{PFCGD}	- 0.3	V _{cc} +0.3	V	
PFCGD Peak Source Current	I _{PFCGDsomax}	- 150	5	mA	< 500 ns
PFCGD Peak Sink Current	I _{PFCGDsimax}	- 100	700	mA	< 100 ns
PFCCS Voltage	V _{PFCCS}	- 5	6	V	
PFCCS Current	I _{PFCCS}	- 3	3	mA	
PFCZCD Voltage	V_{PFCZCD}	- 3	6	V	
PFCZCD Current	I _{PFCZCD}	- 5	5	mA	
PFCVS Voltage	V _{PFCVS}	- 0.3	5.3	V	
RFM Voltage	V_{RFM}	- 0.3	5.3	V	
OTP Voltage	V _{OTP}	- 0.3	5.3	V	
OVP Voltage	V _{OVP}	- 6	7	V	
OVP Current1	I _{OVP_1}	- 1	1	mA	IC in Power Down Mode
OVP Current2	I _{OVP_2}	- 3	3	mA	IC in active mode
HSGND Voltage	V _{HSGND}	- 650	650	V	Referring to GND 1)
HSGND Voltage Transient	dV _{HSGND} /dt	- 40	40	V/ns	
HSVCC Voltage	V _{HSVCC}	- 0.3	18.0	V	Referring to HSGND

¹⁾ Limitation due to voltage capability in end test



Parameter	Symbol	Symbol Limit Values			Remarks
		min.	max.		
HSGD Voltage	V_{HSGD}	- 0.3	V _{HSVCC} +0.3	V	Internally clamped to 11V
HSGD Peak Source Current	I _{HSGDsomax}	- 75	0	mA	< 500ns
HSGD Peak Sink Current	I _{HSGDsimax}	0	400	mA	< 100ns
Junction Temperature	T_J	- 40	150	°C	
Storage Temperature	Ts	- 55	150	°C	
Maximum Power Dissipation	P _{TOT}	_	1	W	PG_DSO-16-23 / T _{amb} =25°C
Thermal Resistance (2 Chips) Junction - Ambient	R_{thJA}	_	125	K/W	PG_DSO-16-23 @ TA = 85°C & PCB Area > 30x20mm
Soldering Temperature Wave		_	260	°C	Wave Soldering ¹⁾
Soldering Temperature Reflow		_	2)	°C	Reflow Soldering
ESD Capability HBM	V_{ESD_HBM}	_	2	kV	Human Body Model ³⁾
ESD Capability CDM	V _{ESD_CDM}	_	1	kV	Charged Device Model ⁴⁾
Rated Bus Voltage (95%)	V _{PFCVS95}	2.33	2.43	V	

¹⁾ According to JESD22A111
2) According to J-STD-020D
3) According to EIA/JESD22-A114-B
4) According to JESD22-C101



Operating Range 3.2

The IC operates as described in the functional description once the values listed here lie within the operating

Parameter	Symbol	Limit \	/alues	Unit	Remarks
		min.	Max.		
HSVCC Supply Voltage	V _{HSVCC}	V _{HSVCCOff}	17.5	V	Referring to HSGND
HSGND Voltage	V _{HSGND}	- 650	650	V	Referring to GND ¹⁾
VCC Voltage @ 25°C	V_{VCC}	V_{VCCOff}	17.5	V	$T_J = 25$ °C
VCC Voltage @ 125°C	V _{VCC}	V_{VCCOff}	18.0	V	T _J = 125°C
LSCS Voltage Range	V _{LSCS}	- 4	5	V	In active mode
PFCVS Voltage Range	V _{PFCVS}	0	4	V	
PFCCS Voltage Range	V _{PFCCS}	- 4	5	V	In active mode
PFZCD Current Range	I _{PFCZCD}	- 3	3	mA	In active mode
OVP Voltage Range	V _{OVP}	- 6	6 ²⁾	V	
OVP, Current Range	I _{OVP}	3)	210	μA	IC Power Down Mode
OVP, Current Range	I _{OVP}	- 2.5	2.5	mA	IC active mode
Junction Temperature	Tj	- 40	125	°C	
Adjustable Run Frequency	f _{RFM}	20	120	kHz	Range set by RFM
Adjustable Run Frequency	f _{RFM}	20	130	kHz	@ - 25°C
Set Resistor for Run Freq.	R _{RFM}	4.1	25	kΩ	
Mains Frequency	f _{Mains}	45	65	Hz	NOTCH Filter Operation

Limitation due to creeping distance between the HS & LS Pins (CTT 900V inside)
 Limited by maximum of current range at OVP
 Limited by minimum of voltage range at OVP



3.3 Characteristics Power Supply Section

Note: The electrical characteristics involve the spread of values given within the specified supply voltage and junction temperature range T_J from -40 °C to 125 °C. Typical values represent the median values, which are given in reference to 25 °C. If not otherwise stated, a supply voltage of 15 V and $V_{HSVCC} = 15$ V is assumed and the IC operates in active mode. Furthermore, all voltages refer to GND if not otherwise mentioned.

Parameter	Symbol	Lin	nit Value	es	Unit	Test Condition
raiailletei	Syllibol	min.	typ.	max.	Oill	rest condition
VCC Quiescent Current1	I _{VCCqu1}		90	130	μΑ	$V_{VCC} = V_{VCCOff} - 0.5V$
VCC Quiescent Current2	I _{VCCqu2}		120	160	μΑ	$V_{VCC} = V_{VCCOn} - 0.5V$
VCC Supply Current 1)	I _{VCCSupply}	_	4.2	6.0	mA	V _{PFCVS} > 2.725V
VCC Supply Current in Latched Fault Mode	I _{VCCLatch}		110	170	μΑ	V _{OTP} = 5V
LSVCC Turn-On Threshold	V_{VCCOn}	13.48	14.0	14.5	V	
LSVCC Turn-Off Threshold LSVCC Turn-On/Off Hyst.	$V_{VCCOff} \ V_{VCCHys}$	10.0 3.2	10.6 3.6	11.0 4.0	V	Hysteresis
VCC Zener Clamp Voltage	VCCClamp	15.5	16.3	16.9	V	$I_{VCC} = 2mA/V_{OTP} = 5V$
VCC Zener Clamp Current	I _{VCCZener}	2.5	_	5.05	mA	$V_{VCC} = 17.5 V/V_{OTP} = 5 V$
High Side Leakage Current	I _{HSGNDleak}	_	0.01	2	μA	$V_{HSGND} = 650V, V_{GND} = 0V$
HSVCC Quiescent Current	I _{HSVCCqu1} ²⁾	_	190	280	μΑ	V _{HSVCC} = V _{HSVCCOn} - 0.5V
HSVCC Quiescent Current ¹⁾	I _{HSVCCqu2} ²⁾	0.26	0.65	1.2	mA	V _{HSVCC} > V _{HSVCCOn}
HSVCC Turn-On Threshold	V _{HSVCCOn} ²	9.75	10.4	11.0	V	
HSVCC Turn-Off Threshold	V HSVCCOff	8.08	8.6	9.3	V	Hysteresis
HSVCC Turn-On/Off Hyst.	V _{HSVCCHy} ²⁾	1.4	1.7	2.03	V	
Low Side Ground	GND					

¹⁾ With inactive gate

3.4 Characteristics of PFC Section

3.4.1 PFC Current Sense (PFCCS)

Parameter	Symbol	Lin	nit Value	es	Unit	Test Condition
	Symbol	min.	typ.	max.		
Turn-off threshold	V _{PFCCSOff}	0.95	1.0	1.05	V	
Overcurrent blanking + propagation delay ¹⁾	t _{PFCCSOff}	140	200	262	ns	
Leading-edge blanking	t _{Blanking}	180	250	315	ns	Pulse width when V _{PFCCS} > 1.0V
PFCCS bias current	I _{PFCCSBias}	- 0.5	_	0.5	μA	V _{PFCCS} = 1.5V

¹⁾ Propagation Delay = 50 ns

²⁾ Refers to high-side ground (HSGND)



PFC Zero Current Detection (PFCZCD) 3.4.2

Parameter	Symbol	Lin	nit Value	es	Unit	Test Condition
Parameter	Syllibol	min.	typ.	max.	Ullit	rest Condition
Zero crossing upper thr. 1)	$V_{PFCZCDUp}$	1.4	1.5	1.6	V	
Zero crossing lower thr. 2)	$V_{PFCZCDLow}$	0.4	0.5	0.6	V	
Zero crossing hysteresis	$V_{PFCZCDHys}$	_	1.0	_	V	
Clamping of pos. voltages	$V_{PFCZCDpclp}$	4.1	4.6	5.12	V	I _{PFCZCDSink} = 2mA
Clamping of neg. voltages	V _{PFCZCDnclp}	- 1.69	- 1.4	- 1.0	V	I _{PFCZCDSource} = -2mA
PFCZCD bias current	I _{PFCZCDBias}	- 0.5	_	5.0	μA	$V_{PFCZCD} = 1.5V$
PFCZCD bias current	I _{PFCZCDBias}	- 0.5	_	0.5	μA	$V_{PFCZCD} = 0.5V$
PFCZCD ringing su.3) time	t _{Ringsup}	350	500	660	ns	
Limit value for ON time extension	Δt x I _{ZCD}	498	700	900	pAxs	

PFC Voltage Sensing Bus (PFCVS) 3.4.3

Parameter	Symbol	Lin	nit Value	es	Unit	Test Condition
raiailletei	Symbol	min.	Тур.	max.	Oilit	
Trimmed reference voltage	V _{PFCVSRef}	2.468	2.50	2.53	V	
Overvoltage turn-off (109 %)	V _{PFCVSRUp}	2.677	2.73	2.78	V	
Overvoltage turn-on (105 %)	V _{PFCVSLow}	2.567	2.63	2.68	V	
Overvoltage hysteresis	$V_{PFCVSHys}$	70	100	130	mV	4 % rated bus voltage
Under voltage (75 %)	V _{PFCVSUV}	1.832	1.88	1.915	V	
Under voltage (12.5 %)	V _{PFCVSUV}	0.237	0.31	0.387	V	
Rated bus voltage (95 %)	V _{PFCVS95}	2.320	2.38	2.425	V	
PFCVS bias current	I _{PFCVSBias}	- 1.0	_	1.0	μΑ	V _{PFCVS} = 2.5V

PFC PWM Generation 3.4.4

Parameter	Symbol	Lin	nit Value	es	Unit	Test Condition
Parameter	Symbol	min.	Тур.	max.		
Initial ON time 1)	t _{PFCON_initial}	_	4.0	_	μs	$V_{PFCZCD} = 0V$
Max. ON time 2)	t _{PFCON_max}	18.0	24.0	28.6	μs	0.45V < V _{PFCVS} < 2.45V
Switch threshold from CrCM to DCM	t _{PFCON_min}	160	270	370	ns	
Repetition time 1)	t _{PFCRep}	47	52	57	μs	$V_{PFCZCD} = 0V$
Off time	t _{PFCOff}	42	47	52.5	μs	

¹⁾ Turn-OFF threshold 2) Turn-ON threshold 3) Ringing suppression time

¹⁾ When missing zero crossing signal ²⁾ At the maximum of the AC line input voltage



PFC Gate Drive (PFCGD) 3.4.5

Darameter	Cumbal	Lin	nit Value	es	Unit	Test Condition
Parameter	Symbol	min.	Тур.	max.	Unit	rest condition
		0.4	0.7	0.92	V	I _{PFCGD} = 5mA
PFCGD Low Voltage	$V_{PFCGDLow}$	0.4	0.75	1.12	V	I _{PFCGD} = 20mA
		- 0.2	0.3	0.62	V	I _{PFCGD} = -20mA
		10.0	11.0	11.6	V	I _{PFCGD} = -20mA
PFCGD High Voltage	$V_{PFCGDHigh}$	8.98	_	_	V	$I_{PFCGD} = -1 \text{mA} / V_{VCC}^{1)}$
		8.47	_	_	V	$I_{PFCGD} = -5mA / V_{VCC}^{1)}$
PFCGD active Shut Down	V _{PFCGASD}	0.4	0.75	1.12	V	$I_{PFCGD} = 20 \text{mA } V_{VCC} = 5 \text{V}$
PFCGD UVLO Shut Down	$V_{PFCGDuvlo}$	0.3	1.0	1.56	V	$I_{PFCGD} = 5mA V_{VCC}=2V$
PFCGD Peak Source Current	I _{PFCGDSouce}	_	- 100	_	mA	2) + 3)
PFCGD Peak Sink Current	I _{PFCGDSink}	_	500	_	mA	2) + 3)
PFCGD Voltage during sink Current	$V_{PFCGDHigh}$	11.0	11.7	12.3	V	I _{PFCGDSinkH} = 3mA
PFC Rise Time	t _{PFCGDRise}	80	245	500	ns	2V > VLSGD > 8V 2)
PFC Fall Time	t _{PFCGDFall}	20	45	72	ns	8V > VLSGD > 2V 2)

3.5 **Characteristics of Inverter Section**

3.5.1 **Low-Side Current Sense (LSCS)**

Parameter	Symbol	Lin	nit Value	es	Unit	Test Condition
raiailletei	Syllibol	min.	typ.	max.	Ollit	
Overcurrent shutdown volt.	V _{LSCSOvC1}	1.5	1.6	1.7	V	1)
Overcurrent shutdown Volt.	V _{LSCSOvC2}	0.75	0.8	0.85	V	2)
Duration of overcurrent	t _{LSCSOvC}	450	600	700	ns	
Capacitive mode det. Level1	V _{LSCSCap1}	- 70	- 50	- 27	mV	
Capacitive mode duration1	t _{LSCSCap1}	_	280	_	ns	3)
Capacitive mode det. Level2	V _{LSCSCap2}	1.8	2.0	2.2	V	
Capacitive mode duration2	t _{LSCSCap2}	_	50	_	ns	4)
LSCS bias current	I _{LSCSBias}	-1.0	_	1.0	μA	@ V _{LSCS} = 1.5 V

Overcurrent voltage threshold active during start-up, soft start, saturation control
 Overcurrent voltage threshold active during run mode
 Active before turn-ON of the HSGD in run mode
 Active during turn-ON of the HSGD in run mode

 $^{^{1)}}$ V_{VCC} = V_{VCCOff} + 0.3V $^{2)}$ R_{Load} = 4 Ω and C_{Load} = 3.3nF $^{3)}$ The parameter is not subject to production testing – verified by design/characterization



Low-Side Gate Drive (LSGD) 3.5.2

Parameter	Symbol	Lin	nit Value	es	Unit	Test Condition
raiametei	Syllibol	min.	typ.	max.	Ollit	
		0.4	0.7	1.02	V	$I_{LSGD} = 5 \text{ mA}^{1)}$
LSGD low voltage	$V_{LSGDLow}$	0.4	8.0	1.22	V	$I_{LSGD} = 20 \text{ mA}^{1)}$
		- 0.3	0.2	0.53	V	I _{LSGD} = - 20 mA (source)
		10.0	10.8	11.6	V	2)
LSGD high voltage	$V_{LSGDHigh}$	8.98	_	_	V	3)
		8.47	_	_	V	4)
LSGD active shutdown	V _{LSGDASD}	0.4	0.75	1.12	V	$V_{CC} = 5 \text{ V} / I_{LSGD} = 20 \text{ mA}^{-1}$
LSGD UVLO shutdown	V _{LSGDUVLO}	0.3	1.0	1.6	V	$V_{CC} = 2 \text{ V} / I_{LSGD} = 5 \text{ mA}$
LSGD peak source current	I _{LSGDSource}	_	- 50	_	mA	5) + 6)
LSGD peak sink current	I _{LSGDSink}	_	300	_	mA	5) + 6)
LSGD voltage during 1)	$V_{LSGDHigh}$	_	11.7	_	V	I _{LSGDsinkH} = 3 mA
LSGD rise time	t _{LSGDRise}	80	245	500	ns	2 V < V _{LSGD} < 8 V ⁵⁾
LSGD fall time	t _{LSGDFall}	20	35	61	ns	$8 \text{ V} > \text{V}_{\text{LSGD}} > 2 \text{ V}^{5)}$

¹⁾ Sink current

Inverter Minimum Run Frequency (RFM) 3.5.3

Parameter	Symbol	Lin	nit Value	es	Unit	Test Condition
raiailletei	Syllibol	min.	typ.	max.	Oill	rest condition
Fixed start-upfrequency	f _{StartUp}	120	135	148.5	kHz	
Duration of soft start	t _{SoftStart}	9	11	13.56	ms	1)
RFM voltage in run mode	V_{RFM}	_	2.5	_	٧	@ 100μA <i<sub>RFM<600μA</i<sub>
Run frequency	f _{RFM}	49	50	51.1	kHz	$R_{RFM} = 10k\Omega^{2}$
	f _{RFM1}	_	20	_	kHz	I _{RFM} = - 100 μA ²⁾
	f _{RFM2}	_	40	_	kHz	I _{RFM} = - 200 μA ²⁾
Adjustable run frequency	f _{RFM3}	_	100	_	kHz	I _{RFM} = - 500 μA ²⁾
	f _{RFM4}	_	120	_	kHz	I _{RFM} = - 600 μA ²⁾
	f _{RFM-25°C}		130	_	kHz	I _{RFM} = - 650 μA ³⁾
RFM max. current range	I _{RFMmax}	_	-1000	- 612	μΑ	@ VRFM = 0V ²⁾

Shift start-up frequency to run frequency
 Run frequency @ - 40°C
 Run frequency @ - 25°C

Sink current $^{2)} I_{LSGD} = -20 \text{ mA source current}$ $^{3)} V_{CCOFF} + 0.3 \text{ V and } I_{LSGD} = -1 \text{ mA source current}$ $^{4)} V_{CCOFF} + 0.3 \text{ V and } I_{LSGD} = -5 \text{ mA source current}$ $^{5)} Load: R_{Load} = 10 \Omega \text{ and } C_{Load} = 1 \text{ nF}$ $^{6)} \text{ The parameter is not subject to production testing - verified by design/characterization}$



3.5.4 Overtemperature Protection (OTP)

Parameter	Symbol	Lin	nit Value	es	Unit	Test Condition
Parameter		min.	typ.	max.)	rest condition
Over Temperature Detection	V_{OTP1}	1.546	1.60	1.65	V	UVLO, V _{CC} < V _{CCON}
	V_{OTP2}	1.247	1.30	1.35	٧	
	V_{OTP3}	_	3.2	_	V	Run Mode
	I _{OTP1}	- 53.2	-42.6	-30.5	μΑ	$V_{OTP} = 1V$; OVP = 5μ A
OTP Current Source	I _{OTP2}	-44.2	-35.4	-25.1	μΑ	$V_{OTP} = 2V$; $OVP = 5\mu A$
OTP Current Source	I _{OTP3}	- 26.6	-21.3	- 15.0	μΑ	$V_{OTP} = 1V$; $OVP = 30\mu A$
	I _{OTP4}	- 22.1	-17.7	-12.3	μΑ	$V_{OTP} = 2V$; $OVP = 30\mu A$

3.5.5 Overvoltage Protection (OVP)

Parameter	Symbol	Lin	nit Value	es	Unit	Test Condition
raiailletei	Syllibol	min.	typ.	max.		
Source Current before Start-Up	I _{OVPEnable}	- 5.0	- 3.0	- 1.9	μΑ	$V_{OVP} = 0V / Vcc < 14.0V$
Enable Monitoring	V _{OVPEnable}	350	530	750	mV	1)
Sink Current for OVP	I _{OVPSink}	7.0	12.0	18.0	μΑ	Vcc < 14.0V
Positive Clamping Voltage	$V_{OVPClamp}$	_	6.5	_	V	@ I _{OVP} = 300μA
AC OVP Current Threshold	I _{OVPSource}	186	210	230	μАрр	
Positive OVP Current Thr.	I _{OVPDCPos}	34	42	50	μАрр	
Neative OVP Current Thr.	I _{OVPDCNeg}	- 50	- 42	- 34	μАрр	

¹⁾ If VovP < VovPEnable monitoring is disabled



3.5.6 High Side Gate Drive (HSGD)

Parameter	Symbol	Lin	nit Valu	es	Unit	Test Condition
Parameter	Symbol	Min.	typ.	max.	Onit	
		0.018	0.05	0.1	V	I _{HSGD} = 5mA (sink)
HSGD Low Voltage	$V_{HSGDLow}$	0.46	1.1	2.5	V	I _{HSGD} = 100mA (sink)
		- 0.4	- 0.2	- 0.04	V	I _{LSGD} = - 20mA (source)
HSGD High Voltage	$V_{HSGDHigh}$	9.7	10.5	11.2	V	V_{CCHS} =15V I_{HSGD} = - 20mA (source)
113GD Flight Voltage		7.8	_	_	٧	$V_{\text{CCHSOFF}} + 0.3V$ $I_{\text{HSGD}} = -1 \text{ mA (source)}$
HSGD active Shut Down	V _{HSGDASD}	0.041	0.22	0.5	٧	$V_{CCHS}=5V$ $I_{HSGD}=20$ mA (sink)
HSGD Peak Source Current	I _{HSGDSource}	_	- 50		mΑ	$R_{Load} = 10\Omega + C_{Load} = 1nF^{1)}$
HSGD Peak Sink Current	I _{HSGDSink}	_	300	_	mA	$R_{Load} = 10\Omega + C_{Load} = 1nF^{1)}$
HSGD Rise Time	T _{HSGDRise}	120	220	300	ns	$2V < V_{LSGD} < 8V$ $R_{Load} = 10\Omega + C_{Load} = 1nF$
HSGD Fall Time	T _{HSGDFall}	19	35	70	ns	$8V > V_{LSGD} > 2V$ $R_{Load} = 10\Omega + C_{Load} = 1nF$

¹⁾ The parameter is not subject to Production Test – verified by Design / Characterization

3.6 Timer Section

Delay Timer 1	t _{TIMER1}	70	100	163.6	ms	For Fault Detection
Delay Timer 2	t _{TIMER2}	74	84	94	ms	For V _{BUS} > 95%
Inverter Time	t _{Inv}	100	130	163	μs	
Inverter Dead Time Max	t _{DeadMax}	0.85	1.05	1.25	μs	V_GD_th = 2V
						$R_{Load} = 10\Omega + C_{Load} = 1nF$
Inverter Dead Time Min	t _{DeadMin}	400	500	650	ns	$V_{GD_{th}} = 2V$
						$R_{Load} = 10\Omega + C_{Load} = 1nF$
Δ Inverter Dead Time Max	t _{DeadMax}	- 200	_	200	ns	
Δ Inverter Dead Time Min	t _{DeadMin}	- 200	_	200	ns	
Min. Duration of Sat. Control	t _{Saturationmin}	34	40	48	ms	
Max. Duration of Sat. Control	t _{Saturationmax}	197	_	236	ms	
Duration of Ext. Sat. Mode	t _{ExtSat}	565	625	685	ms	

Application Example



4 Application Example

4.1 Schematic

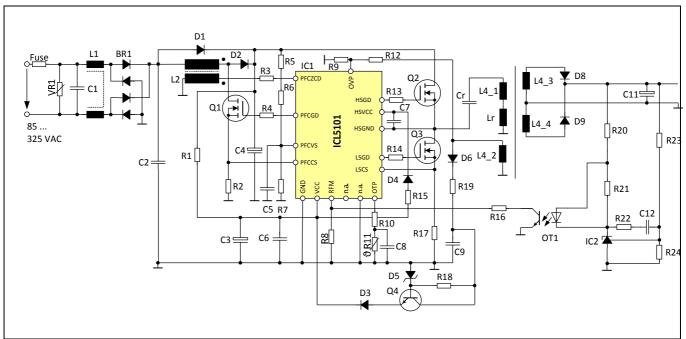


Figure 25 Schematic LED Driver using PFC / LLC Topology for 110W / 54V



5 Outline Dimensions

Outline dimensions are shown in Figure 26.

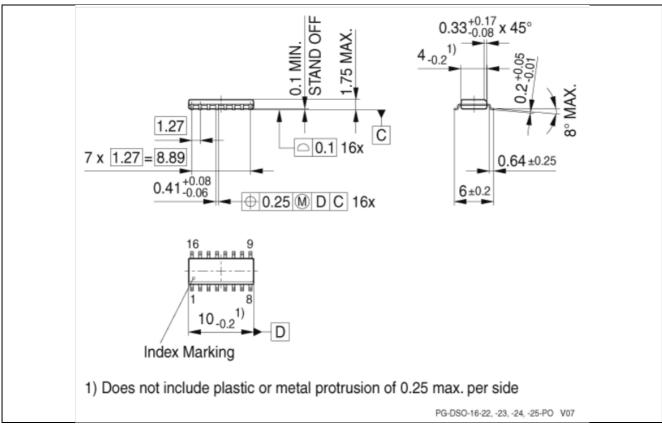


Figure 26 PG-DSO-16-23

Notes

- 1. You can find all of our packages, sorts of packing and others in our Infineon Internet Page "Products": http://www.infineon.com/products.
- 2. Dimensions in mm.

Edition 2013-11-08
Published by
Infineon Technologies AG
81726 Munich, Germany
© 2016 Infineon Technologies AG
All Rights Reserved.

Legal Disclaimer

The infromation given in this document shall in no event be regarded as a guarantee of conditions or characteristics. With respect to any examples or hints given herein, any typical values stated herein and/or any infromation regarding the application of the device, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation, warranties of non-infringement of intellectual property rights of any third party.

Infromation

For further infromation on technology, delivery terms and conditions and prices, please contact the nearest Infineon Technologies Office (www.infineon.com).

Warnings

Due to technical requirements, components may contain dangerous substances. For infromation on the types in question, please contact the nearest Infineon Technologies Office.

Infineon Technologies components may be used in life-support devices or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.



Revision History: 2016-01-15	
Previous Revision: 2015-09-23	
Page or Item	Subjects (major changes since previous revision)
Page 8 / 30 / 34	RUN Frequency: 120 kHz @ - 40 °C / 130 kHz @ - 25 °C
All	Deleted Confidential
3.5.5	OVP: wrong Value Deleting / Index Adjustment
All	Complete Review
Pages: 2 / 40	Figure Updates: 1 / 25 replacement of D7
Page: 24	Figure Updates: 18 replacement of D7 / 19 update
All	Complete Review

Trademarks of Infineon Technologies AG

AURIX™, C166™, CanPAK™, CIPOS™, CIPURSE™, EconoPACK™, CoolMOS™, CoolSET™, CORECONTROL™, CROSSAVE™, DAVE™, DI-POL™, EasyPIM™, EconoBRIDGE™, EconoDUAL™, EconoPIM™, EconoPACK™, EiceDRIVER™, eupec™, FCOS™, HITFET™, HybridPACK™, I²RF™, ISOFACE™, IsoPACK™, MIPAQ™, ModSTACK™, my-d™, NovalithIC™, OptiMOS™, ORIGA™, POWERCODE™, PRIMARION™, PrimePACK™, PrimeSTACK™, PRO-SIL™, PROFET™, RASIC™, ReverSave™, SatRIC™, SIEGET™, SINDRION™, SIPMOS™, SmartLEWIS™, SOLID FLASH™, TEMPFET™, thinQ!™, TRENCHSTOP™, TriCore™.

Other Trademarks

Advance Design System™ (ADS) of Agilent Technologies, AMBA™, ARM™, MULTI-ICE™, KEIL™, PRIMECELL™, REALVIEW™, THUMB™, µVision™ of ARM Limited, UK. AUTOSAR™ is licensed by AUTOSAR development partnership. Bluetooth™ of Bluetooth SIG Inc. CAT-iq™ of DECT Forum. COLOSSUS™, FirstGPS™ of Trimble Navigation Ltd. EMV™ of EMVCo, LLC (Visa Holdings Inc.). EPCOS™ of Epcos AG. FLEXGO™ of Microsoft Corporation. FlexRay™ is licensed by FlexRay Consortium. HYPERTERMINAL™ of Hilgraeve Incorporated. IEC™ of Commission Electrotechnique Internationale. IrDA™ of Infrared Data Association Corporation. ISO™ of INTERNATIONAL ORGANIZATION FOR STANDARDIZATION. MATLAB™ of MathWorks, Inc. MAXIM™ of Maxim Integrated Products, Inc. MICROTEC™, NUCLEUS™ of Mentor Graphics Corporation. MIPI™ of MIPI Alliance, Inc. MIPS™ of MIPS Technologies, Inc., USA. muRata™ of MURATA MANUFACTURING CO., MICROWAVE OFFICE™ (MWO) of Applied Wave Research Inc., OmniVision™ of OmniVision Technologies, Inc. Openwave™ Openwave Systems Inc. RED HAT™ Red Hat, Inc. RFMD™ RF Micro Devices, Inc. SIRIUS™ of Sirius Satellite Radio Inc. SOLARIS™ of Sun Microsystems, Inc. SPANSION™ of Spansion LLC Ltd. Symbian™ of Symbian Software Limited. TAIYO YUDEN™ of Taiyo Yuden Co. TEAKLITE™ of CEVA, Inc. TEKTRONIX™ of Tektronix Inc. TOKO™ of TOKO KABUSHIKI KAISHA TA. UNIX™ of X/Open Company Limited. VERILOG™, PALLADIUM™ of Cadence Design Systems, Inc. VLYNQ™ of Texas Instruments Incorporated. VXWORKS™, WIND RIVER™ of WIND RIVER SYSTEMS, INC. ZETEX™ of Diodes Zetex Limited.

Last Trademarks Update 2011-11-11

www.infineon.com



Компания «Океан Электроники» предлагает заключение долгосрочных отношений при поставках импортных электронных компонентов на взаимовыгодных условиях!

Наши преимущества:

- Поставка оригинальных импортных электронных компонентов напрямую с производств Америки, Европы и Азии, а так же с крупнейших складов мира;
- Широкая линейка поставок активных и пассивных импортных электронных компонентов (более 30 млн. наименований);
- Поставка сложных, дефицитных, либо снятых с производства позиций;
- Оперативные сроки поставки под заказ (от 5 рабочих дней);
- Экспресс доставка в любую точку России;
- Помощь Конструкторского Отдела и консультации квалифицированных инженеров;
- Техническая поддержка проекта, помощь в подборе аналогов, поставка прототипов;
- Поставка электронных компонентов под контролем ВП;
- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001;
- При необходимости вся продукция военного и аэрокосмического назначения проходит испытания и сертификацию в лаборатории (по согласованию с заказчиком);
- Поставка специализированных компонентов военного и аэрокосмического уровня качества (Xilinx, Altera, Analog Devices, Intersil, Interpoint, Microsemi, Actel, Aeroflex, Peregrine, VPT, Syfer, Eurofarad, Texas Instruments, MS Kennedy, Miteq, Cobham, E2V, MA-COM, Hittite, Mini-Circuits, General Dynamics и др.);

Компания «Океан Электроники» является официальным дистрибьютором и эксклюзивным представителем в России одного из крупнейших производителей разъемов военного и аэрокосмического назначения «JONHON», а так же официальным дистрибьютором и эксклюзивным представителем в России производителя высокотехнологичных и надежных решений для передачи СВЧ сигналов «FORSTAR».



«JONHON» (основан в 1970 г.)

Разъемы специального, военного и аэрокосмического назначения:

(Применяются в военной, авиационной, аэрокосмической, морской, железнодорожной, горно- и нефтедобывающей отраслях промышленности)

«**FORSTAR**» (основан в 1998 г.)

ВЧ соединители, коаксиальные кабели, кабельные сборки и микроволновые компоненты:

(Применяются в телекоммуникациях гражданского и специального назначения, в средствах связи, РЛС, а так же военной, авиационной и аэрокосмической отраслях промышленности).



Телефон: 8 (812) 309-75-97 (многоканальный)

Факс: 8 (812) 320-03-32

Электронная почта: ocean@oceanchips.ru

Web: http://oceanchips.ru/

Адрес: 198099, г. Санкт-Петербург, ул. Калинина, д. 2, корп. 4, лит. А